

Electron-Cloud Simulations for SPS and LHC

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(1) Introduction

(2) Model

– primary electrons, secondaries, space charge

(3) Results

– LHC and SPS

– cloud-build up, heat load, instabilities, cures?

(4) Conclusions

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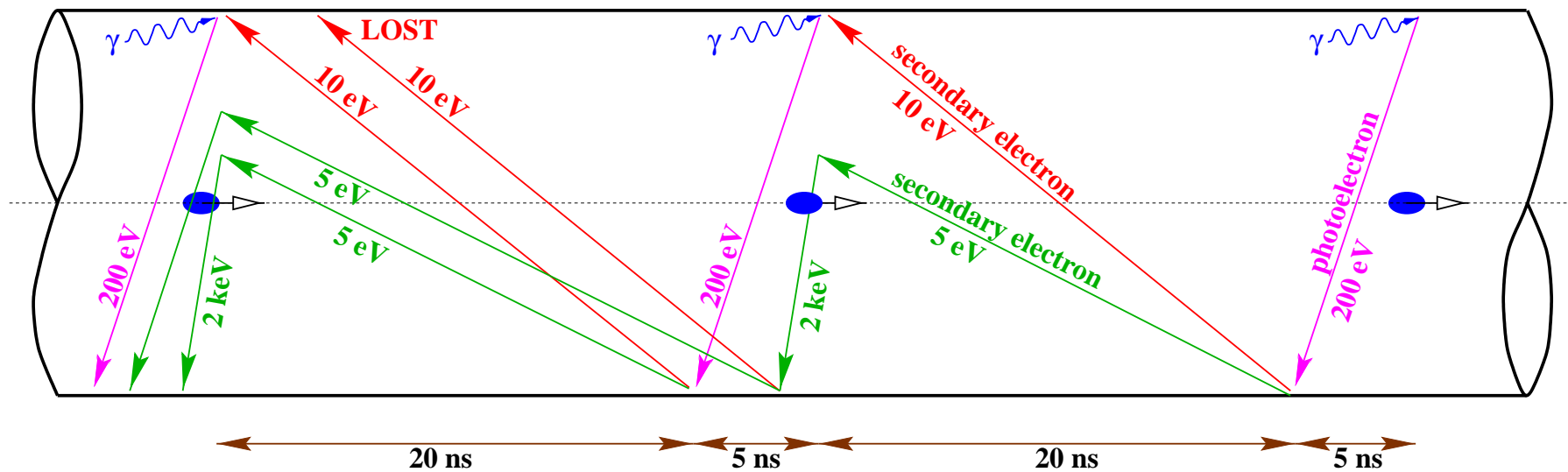
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web page: <http://wwwslap.cern.ch/collective/>

Brief History

- 1977 beam-induced multipacting observed with Al chamber in **ISR** → *pressure rise*
- in 1980s some concern for LHC
- 1989 electron cloud effect at **KEK photon factory** → *increased vertical beam size, coupled oscillation, low threshold current, broad distributions of sidebands; clearing gap does not help*
- 1996 experiments at **BEPC** (IHEP-KEK collaboration)
- 1997 **crash programs** for PEP-II (*simulations, TiN coating,...*) and **LHC**
- 1998–99 electron cloud in the SPS, 1999 **KEKB**

(1) Introduction



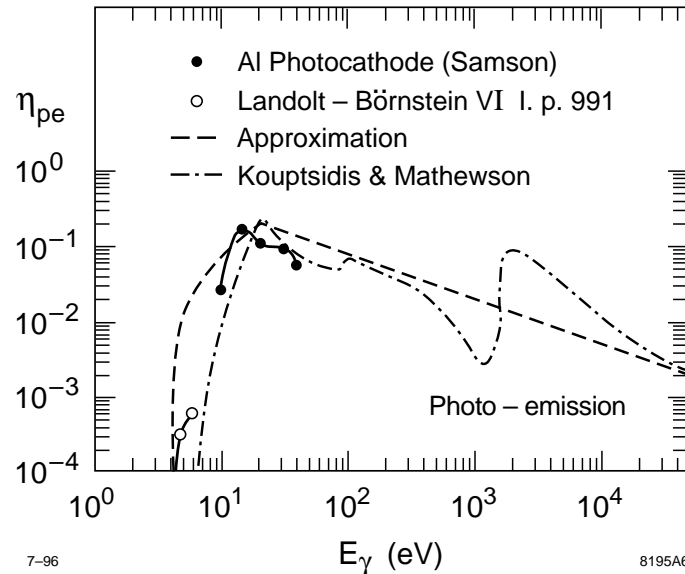
Schematic of **electron-cloud build up** in the LHC beam pipe.

Primary Electrons

LHC: photoemission from synchrotron radiation

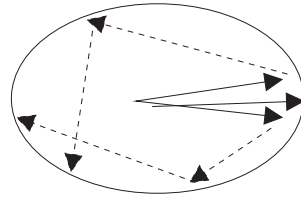
$$N_{\gamma} = \frac{5}{2\sqrt{3}} \alpha_{\gamma} \frac{\text{photons}}{\text{radian}} \quad \text{or} \quad 0.025 \frac{\text{photons}}{\text{proton meter}}$$

critical photon energy: $E_c \sim 45 \text{ eV}$

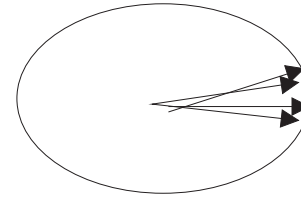


Measured photoemission yields for aluminum vs. photon energy.

Reflectivity



$R = 1$



$R \ll 1$

Electron yield per absorbed photon is $Y^* = Y/(1 - R) \sim 0.05$ with Y the photoelectron yield per incident photon and R photon reflectivity
Hence, for the LHC we estimate

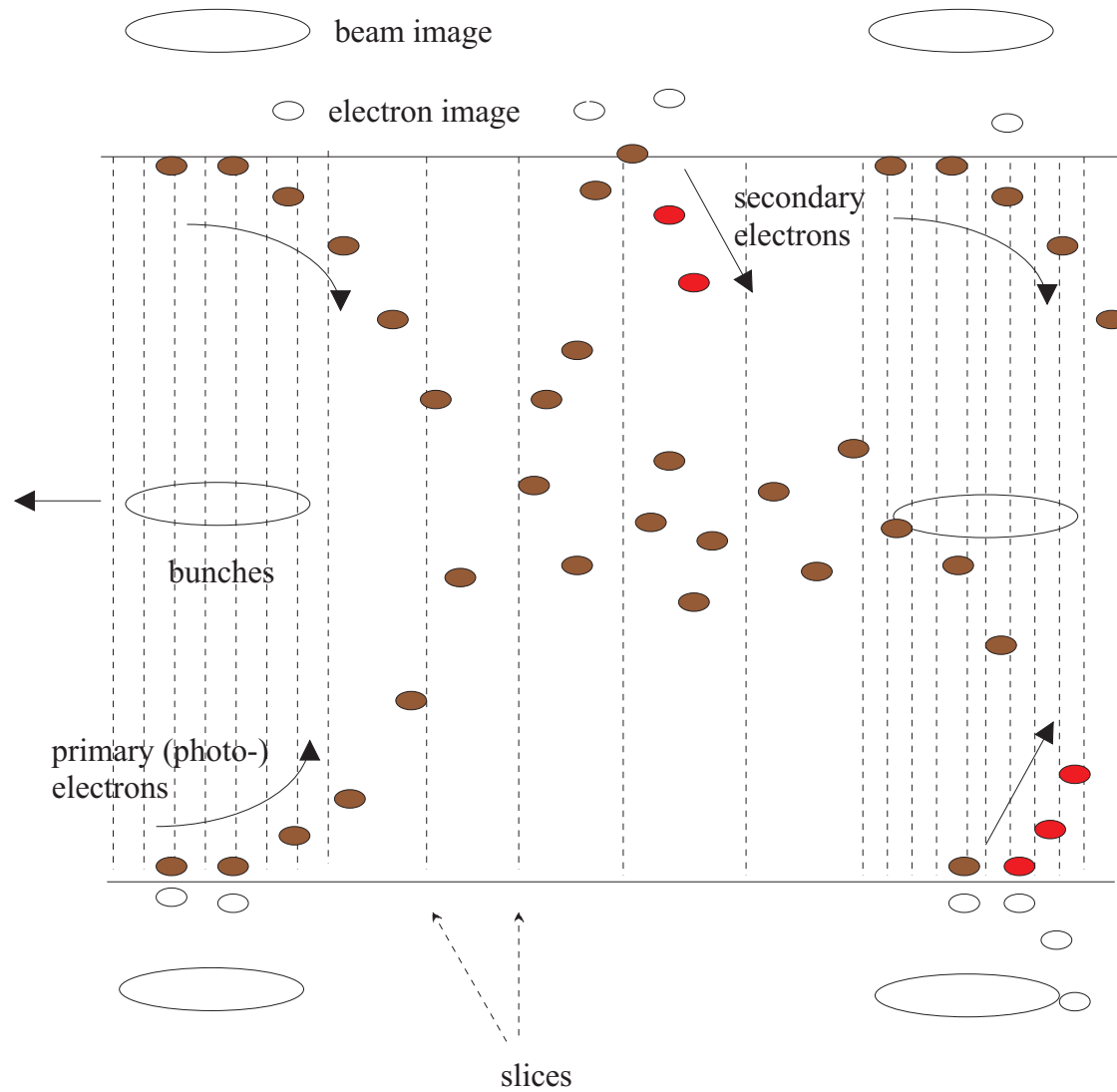
$$\frac{d\lambda_e}{ds} \approx 10^{-3} \frac{\text{photo - electrons}}{\text{proton meter}}$$

SPS: ionization of the residual gas

$$\frac{d\lambda_e}{ds} = \frac{p}{k_B T} \sigma_{ion} \approx 6 p[\text{Torr}] \frac{\text{electrons}}{\text{proton meter}} < 10^{-7} \frac{\text{electrons}}{\text{proton meter}}$$

parameter	symbol	LHC	SPS
beam energy	E	7000 GeV	26 GeV
bunch population	N_b	1.05×10^{11}	$\sim 4 \times 10^{10}$
rms beam sizes	$\sigma_{x,y}$	303 μm	1.5, 1.0 mm
rms bunch length	σ_z	7.7 cm	30 cm
bunch spacing	L_{sep}	7.48 m	7.48 m
vacuum chamber 1/2 height	h_y	18 mm	22.5 mm
vacuum chamber 1/2 width	h_x	22 mm	70 mm
max. secondary emission yield	δ_{\max}	1.0–2.3	≤ 2.0
photon reflectivity	R	2–10%	—
photo-electron yield	Y^*	0.025–0.05	—
primary yield/meter/proton	$d\lambda_e/ds$	$\sim 10^{-3} \text{ m}^{-1}$	10^{-7} m^{-1}

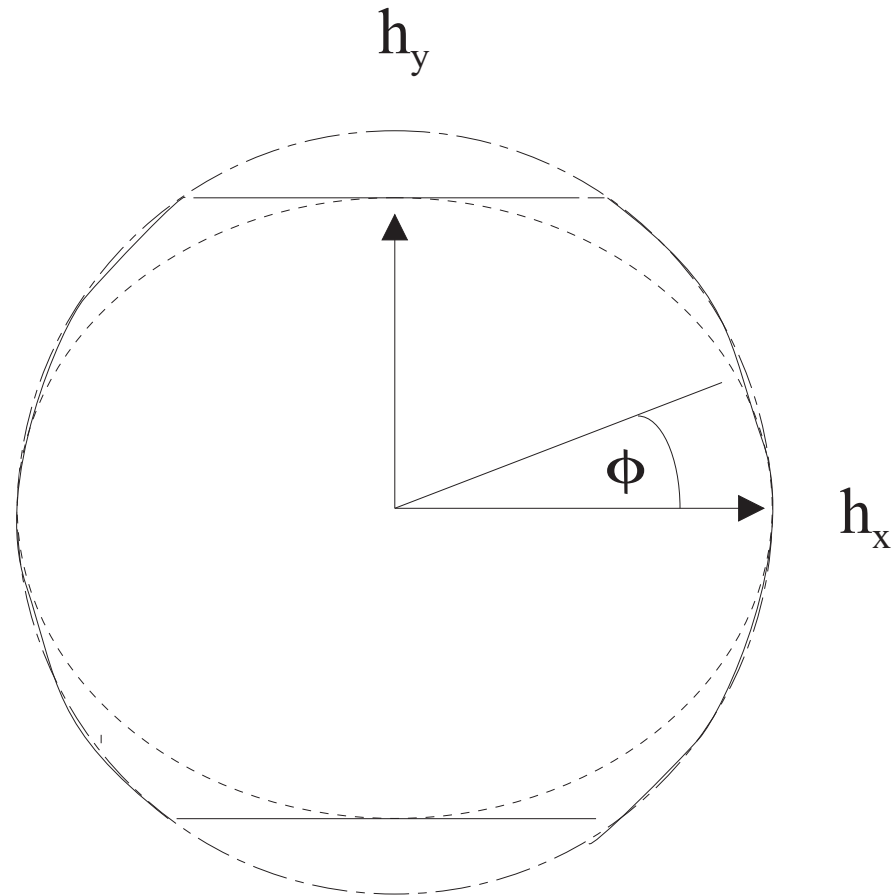
(2) Model



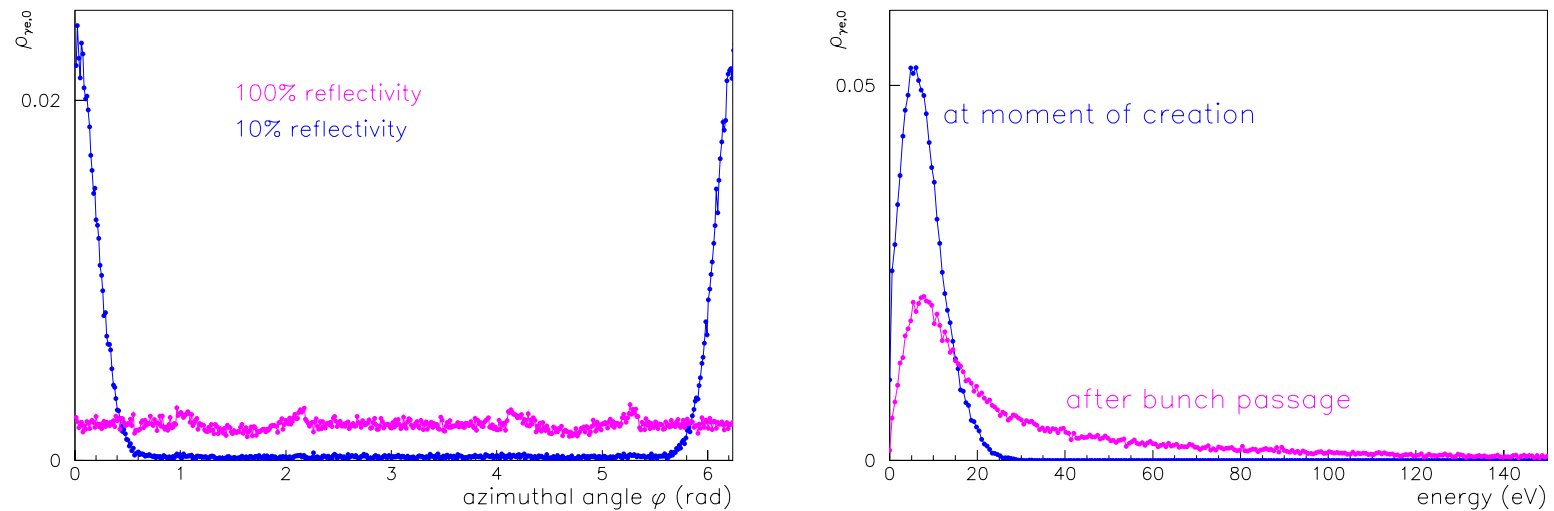
Simulation recipe:

- represent e^- by **macro-particles** (2000/bunch), split bunches and interbunch gaps into **slices**
- for each bunch slice, create **photoelectrons** and **accelerate** existing e^- in beam and beam-image fields
- if e^- hit the wall \rightarrow **secondary e^-** ; change macro charge
- at each gap slice the e^- are **propagated in the magnetic field**; kicks from e^- space-charge and e^- image charges

- energy of lost e^- \rightarrow heat load
- e^- cloud density \rightarrow single-bunch wakefield
- force on bunch behind a displaced bunch \rightarrow multibunch wakefield



Solid line describes the actual cross section of the beam screen. Sometimes we approximate it by the inscribed ellipse, *e.g.*, for accurate modeling of image charges.



Initial photoelectron distribution. **Left:** azimuthal density for 10% and 100% photon reflectivity. Unreflected photons are limited to an outward cone of rms angle 11.25° . **Right:** energy distribution at moment of emission (Gaussian with peak at 7 eV and rms value 5 eV) and after bunch passage. The bunch imparts a maximum momentum of $E_{max} = 2m_0c^2 (N_b r_e / b)^2 \approx 200\text{eV}$. Random emission angles ϕ and θ ($\theta > \pi/2$).

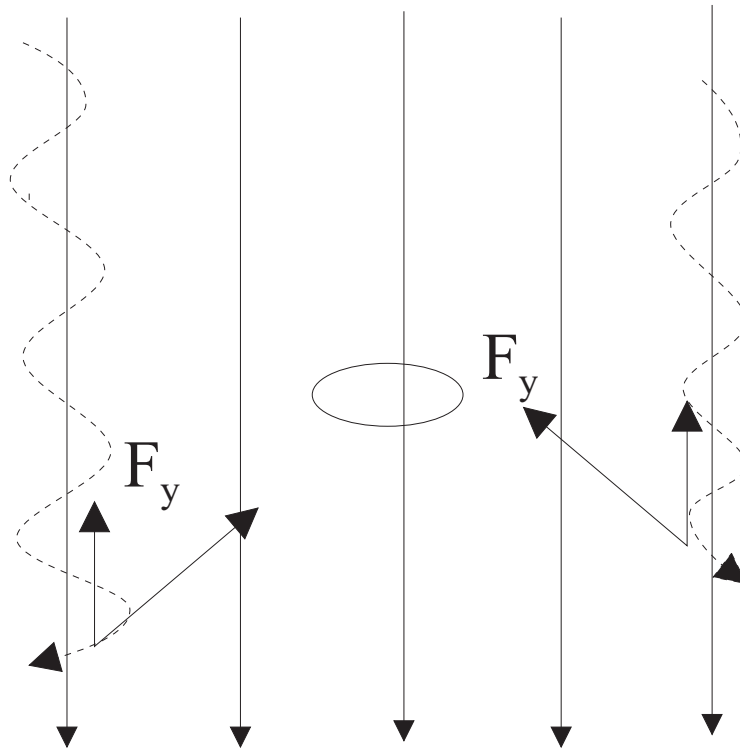
Electron Motion

simulations can be performed for

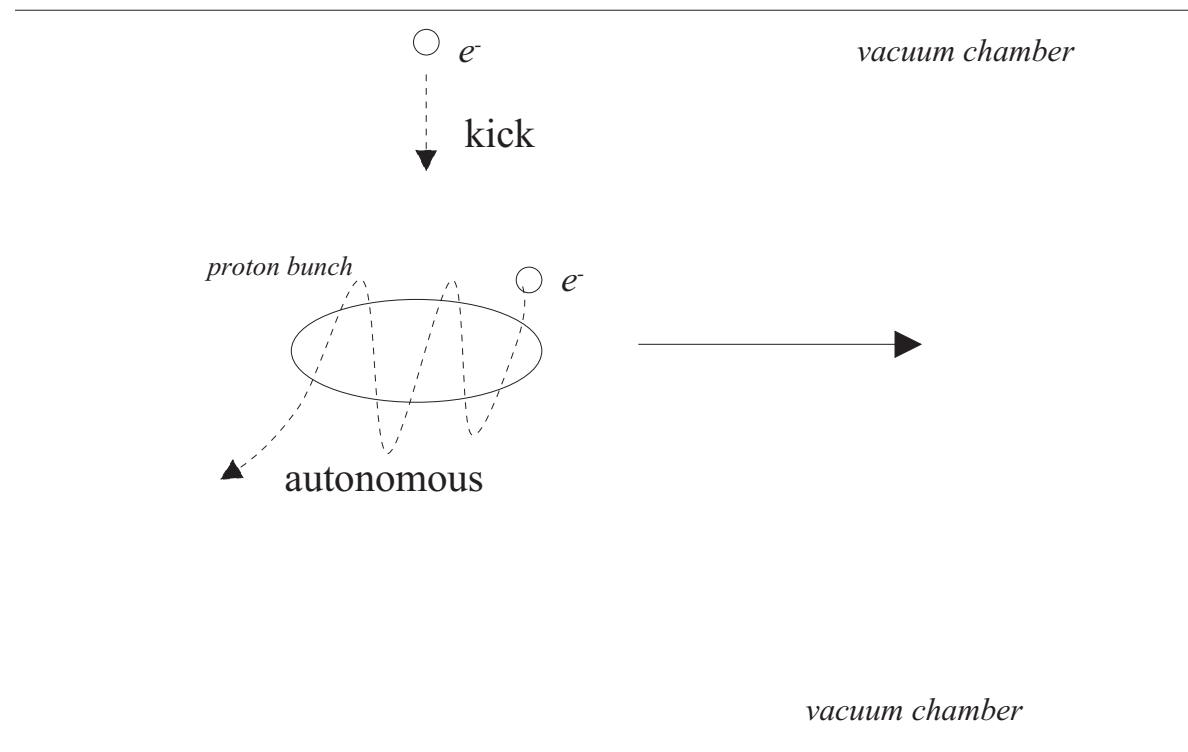
- drift space
- strong dipole field: only **vertical motion**, vertical kick from passing bunch, horizontal kick averages to zero due to large number of cyclotron oscillations/bunch

$$\frac{eBc}{m_e c^2} \frac{2\sigma_z}{2\pi} \approx 120 \text{ (LHC)}, 12 \text{ (SPS at 26 GeV)}$$

- weak dipole & solenoid fields
- quadrupole, or arbitrary field (Runge-Kutta, O. Brüning)



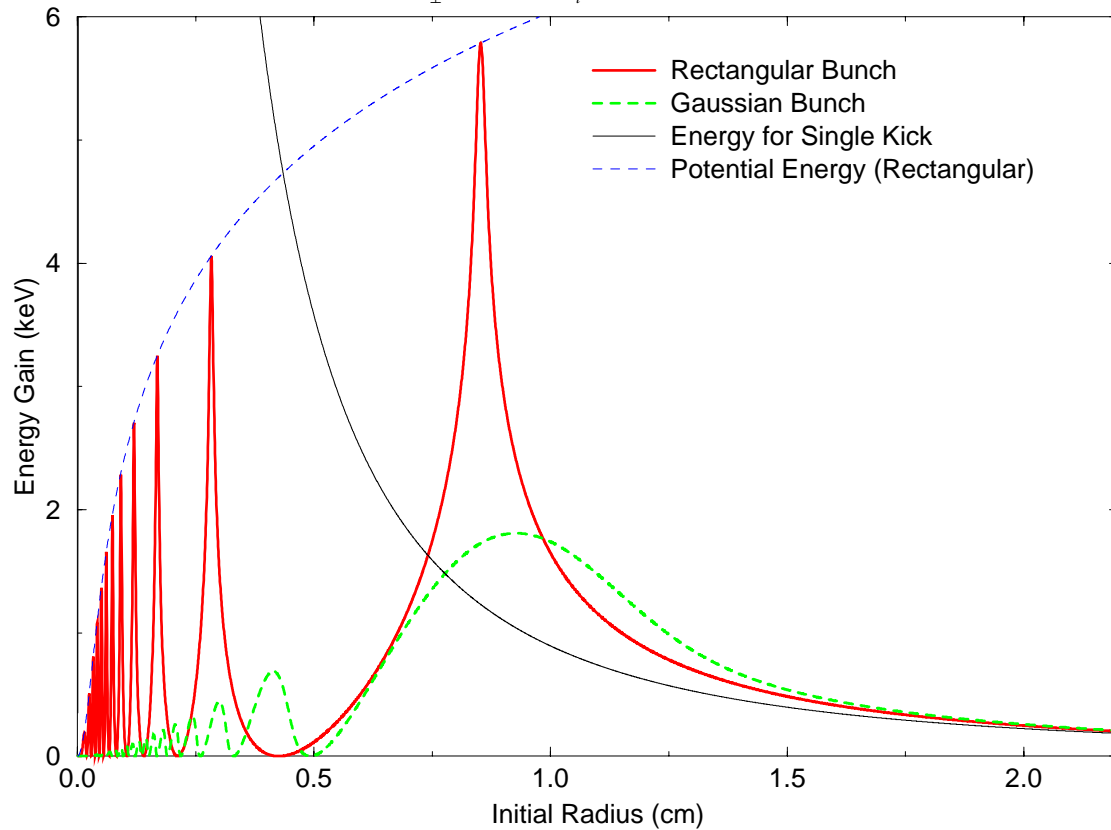
The electrons spiral in the 8.4-T field with a typical radius $\rho = p/(eB)$ of $6\mu\text{m}$ for 200 eV, and $26\mu\text{m}$ for 4 keV. A net vertical kick is applied; the $E \times B$ longitudinal drift is ignored.



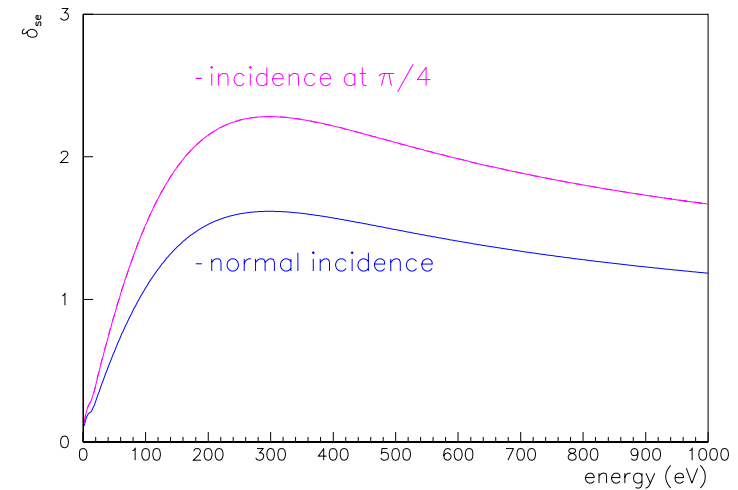
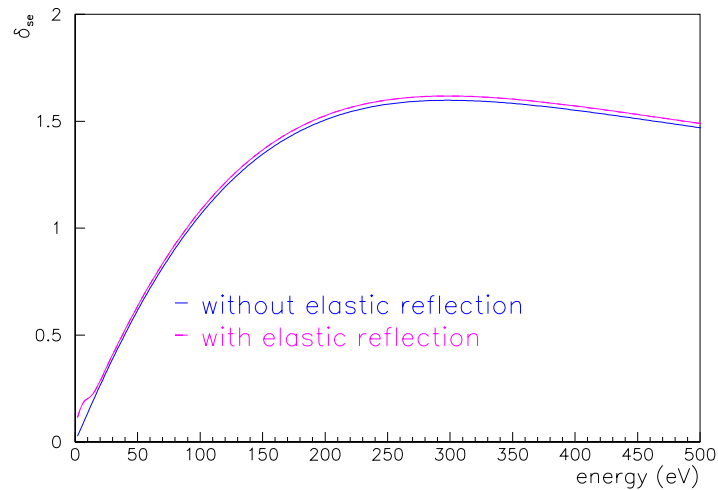
Depending on its initial position when a bunch passes by, an electron may either receive a **single kick** or perform **many oscillations** in the bunch potential.

Energy Gain of Stationary Electron (No Magnetic Field)

LHC: $\sigma_{\perp}=0.2$ mm, $\sigma_r=7.7$ cm, $N=1.05\times 10^{11}$



Maximum energy gain vs. initial particle radius for nominal LHC parameters (S. Berg). Autonomous and kick regions.



Secondary emission yield vs. primary electron energy E_p , for $\delta_{\max} = 1.6$ and $E_{\max} = 300$ eV. **Left:** with and without elastic reflection. **Right:** for two different angles of incidence.

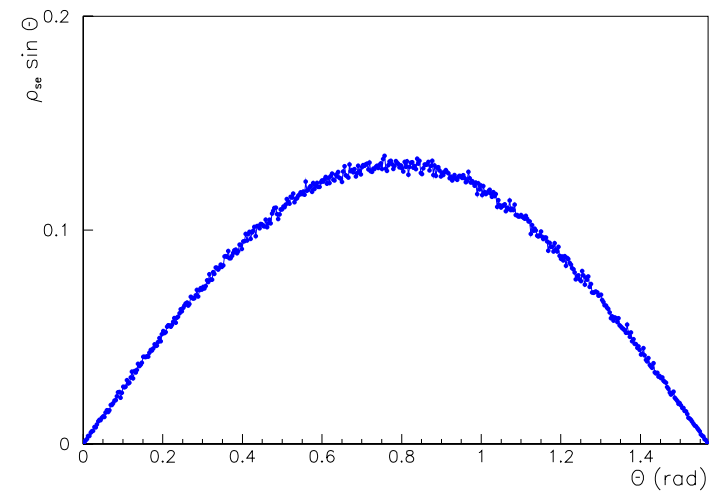
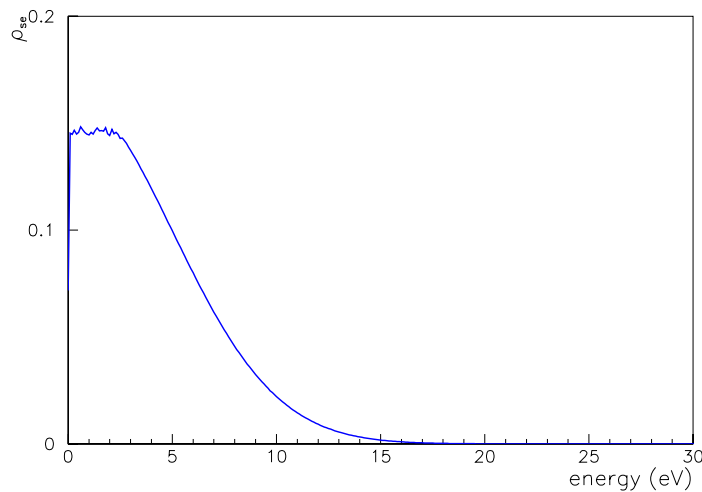
Analytical expression for secondary emission yield [H. Seiler, J. Appl. Phys. 54 (11) (1983)]:

$$\delta_{se}(E_p, \theta) = \delta_{\max} 1.11 x^{-0.35} \frac{1 - e^{-2.3x^{1.35}}}{\cos \theta}$$

with θ the angle of incidence w.r.t. surface normal and $x = E_p/E_{\max}$. Additional yield from elastic reflections:

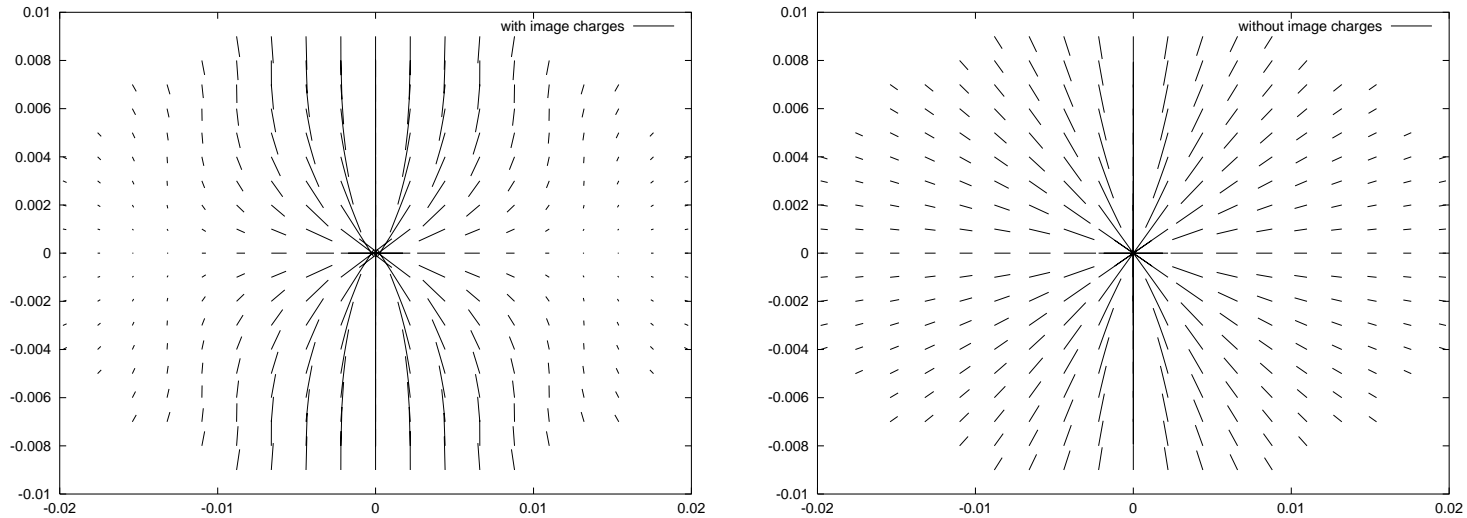
$$\delta_e = \delta_{e,\infty} + (\hat{\delta}_e - \delta_{e,\infty}) \exp\left(\frac{-(E - E_e)^2}{2\Delta^2}\right)$$

with $\hat{\delta}_e = 0.1$, $\delta_{e,\infty} = 0.02$ and $\Delta = 5$ eV.



Initial distribution of **secondary electrons**. **Left**: density vs. **energy**. **Right**: density $dN/d\theta$ vs. polar angle θ w.r.t. surface normal, assuming $dN/d\Omega = \cos \theta$.

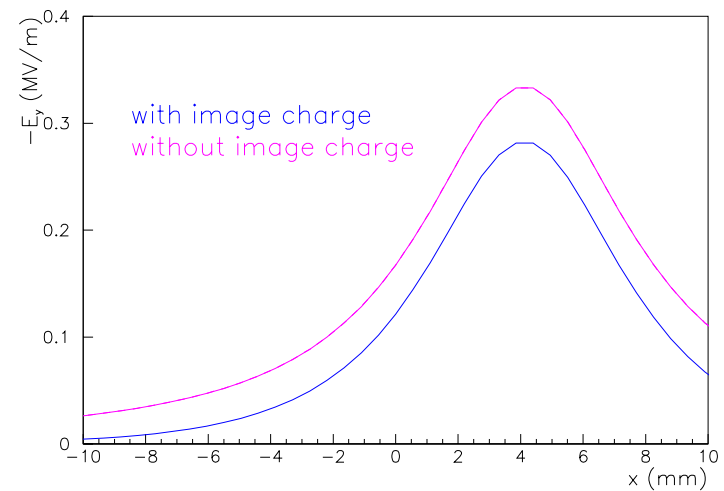
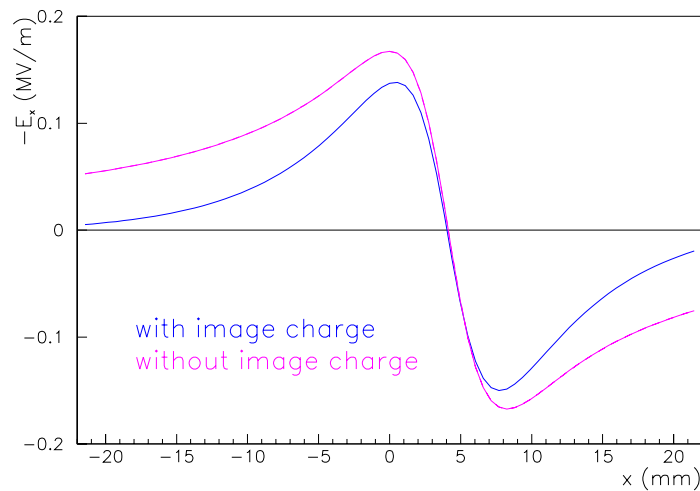
Beam Field and Image Charges



Electric field pattern for a beam centered in an elliptical chamber with [left] and without [right] image charges. Field (M. Furman):

$$\mathcal{E} \approx \frac{2}{\bar{z} - \bar{z}_0} + \frac{4}{g} \sum_{n=1}^8 e^{-n\mu_c} \left[\frac{\cosh n\mu_0 \cos n\phi_0}{\cosh n\mu_c} + i \frac{\sinh n\mu_0 \sin n\phi_0}{\sinh n\mu_c} \right] \frac{\sinh n\bar{q}}{\sinh \bar{q}}$$

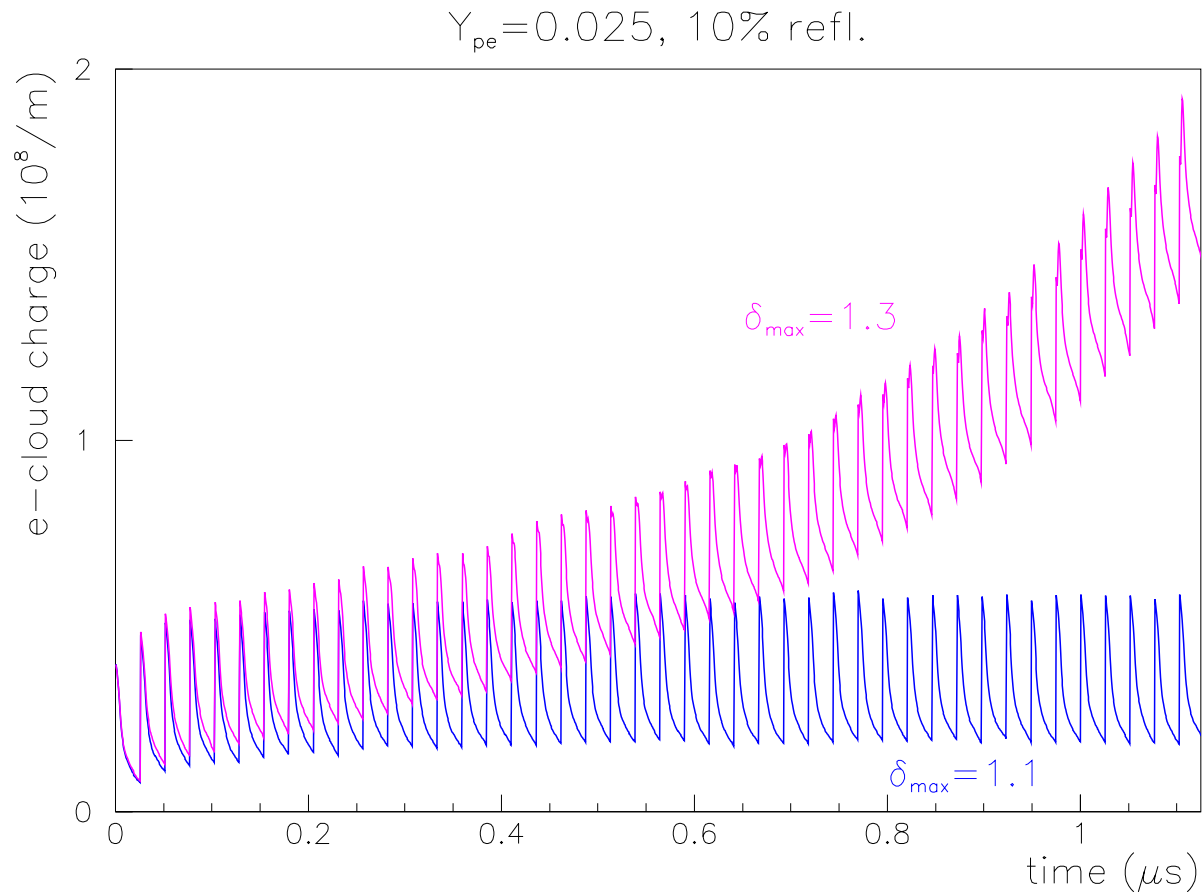
where $z = x + iy = g \cosh q = g \cosh (\mu + i\phi)$ test position, $z_0 = x_0 + iy_0 = g \cosh q_0 = g \cosh (\mu_0 + i\phi_0)$ source, $g = \sqrt{a^2 - b^2}$, $\mu_c = \tanh^{-1}(b/a)$.



Horizontal (left) and vertical average electric beam field vs. horizontal position, for an elliptical chamber with 22×10 mm half apertures, and a beam offset of $+4.3$ mm in both transverse planes.

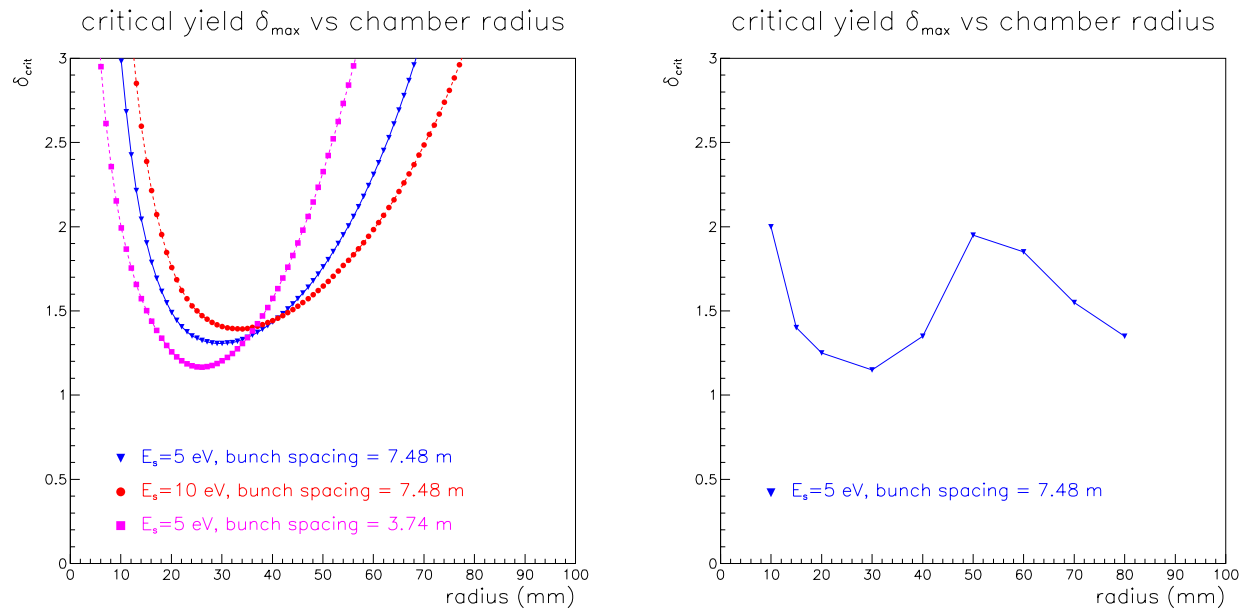
(3) Results

- e^- cloud **build up** for LHC and SPS
- electron distribution
- LHC **heat load**
- multibunch instability
- **single-bunch instability**
- reliefs and cures: **fill patterns**,...

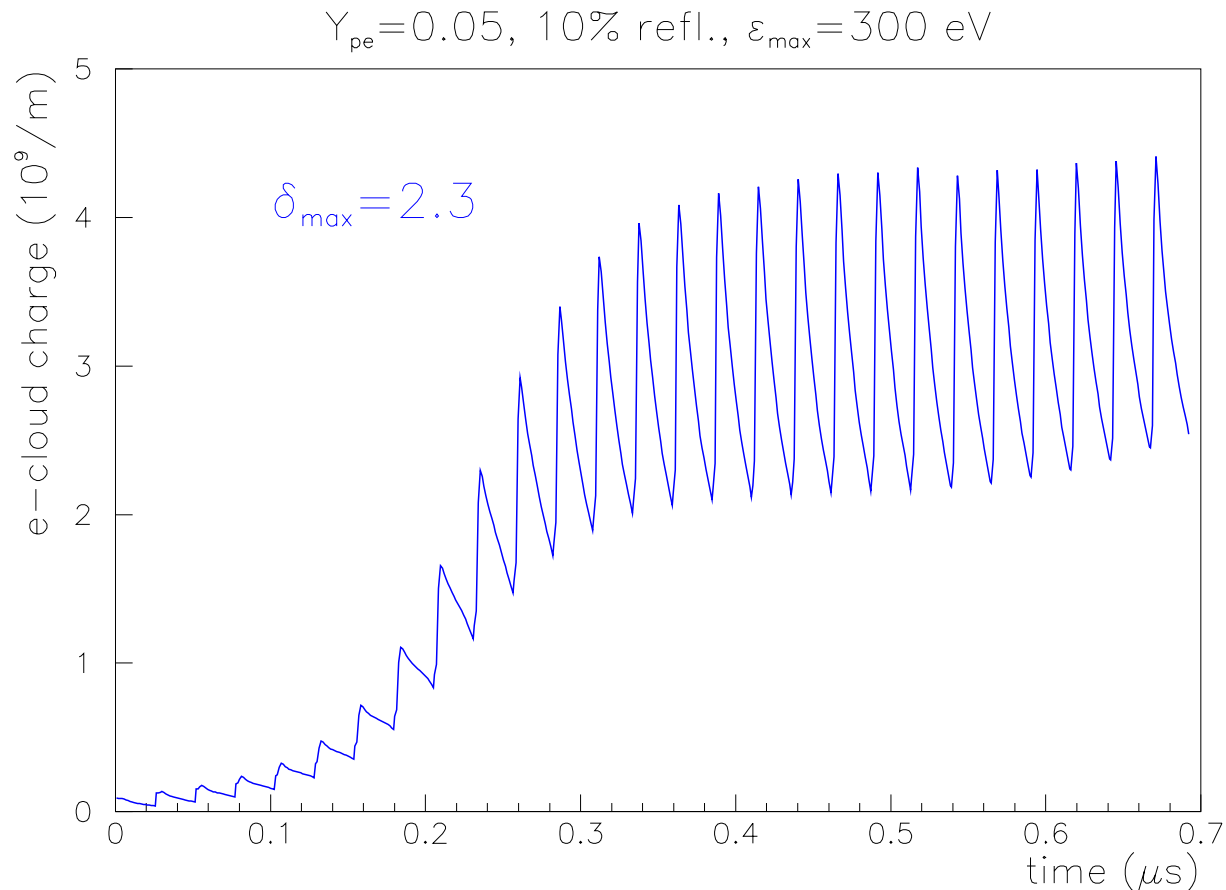


Electron charge per meter in an LHC dipole chamber vs. time along bunch train, comparing $\delta_{\max} = 1.1$ and $\delta_{\max} = 1.3$. Critical yield is between these values. Other parameters: $\epsilon_{\max} = 450$ eV, $R = 0.1$, and $Y^* = 0.025$.

Dependence on Beam Pipe Radius

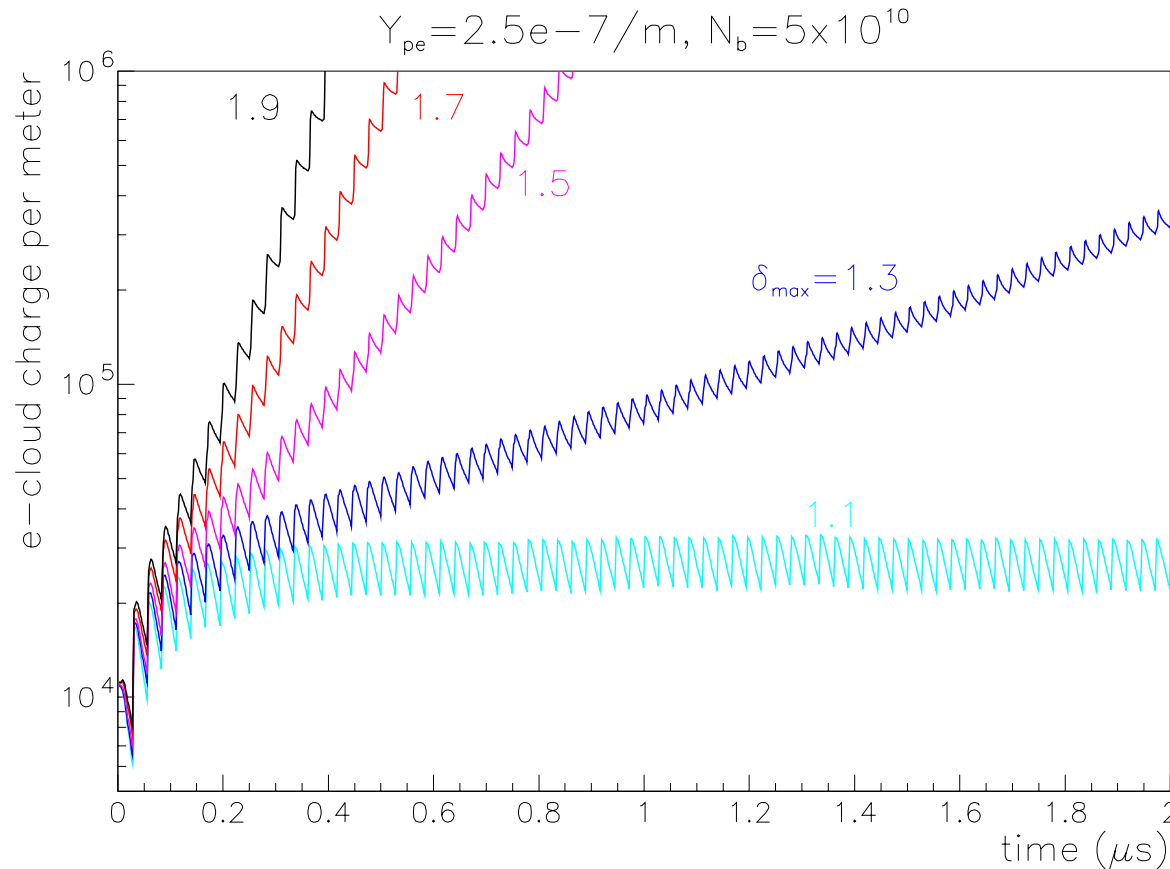


Critical yield as a function of round-chamber radius in a dipole field. Left: numerical evaluation of the above equation for $x = 0$, considering two different values of the characteristic emission energy E_s and of the bunch spacing $l_{sep} = ct_{sep}$; right: simulation for nominal bunch spacing.

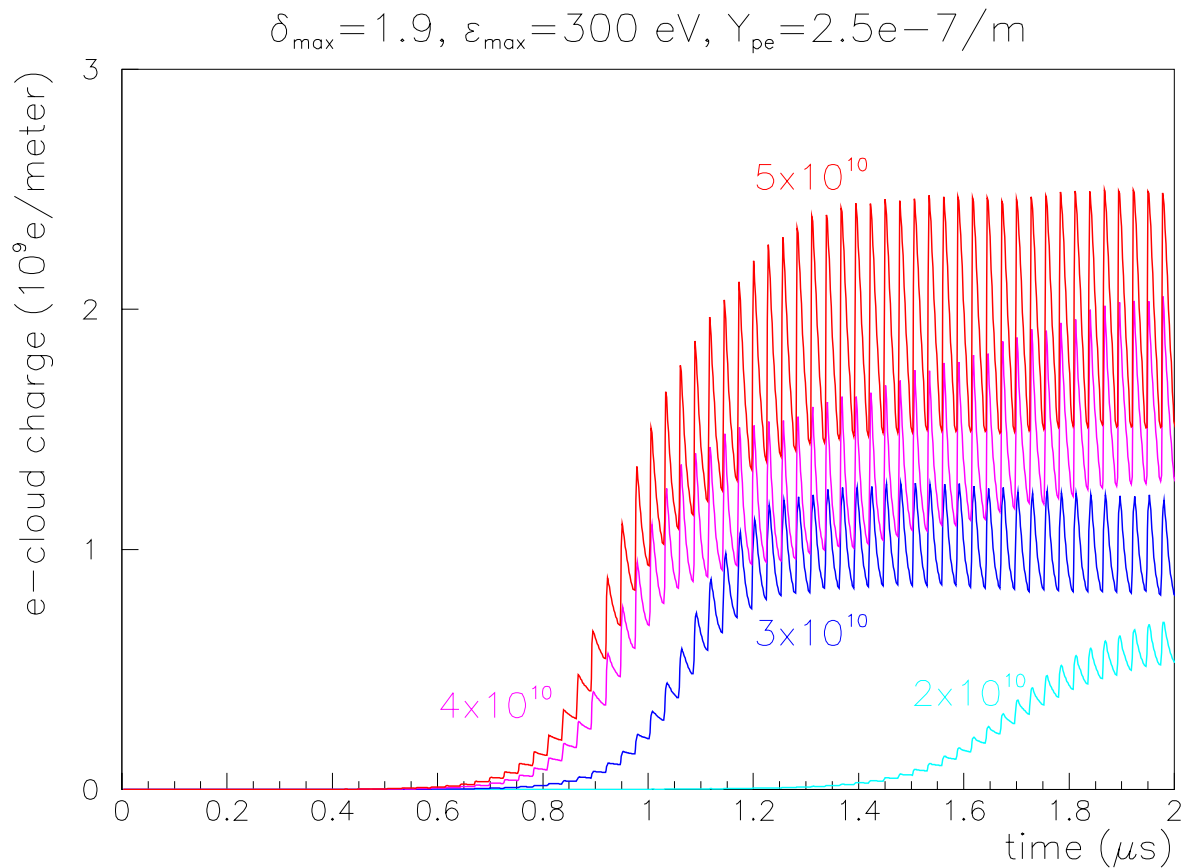


Electron charge per meter in an LHC dipole chamber vs. time along bunch train for large secondary emission yield $\delta_{\max} = 2.3$. Build-up saturates due to electron-cloud space charge. Other parameters: $\epsilon_{\max} = 300 \text{ eV}$, $R = 0.1$, $Y^* = 0.05$.

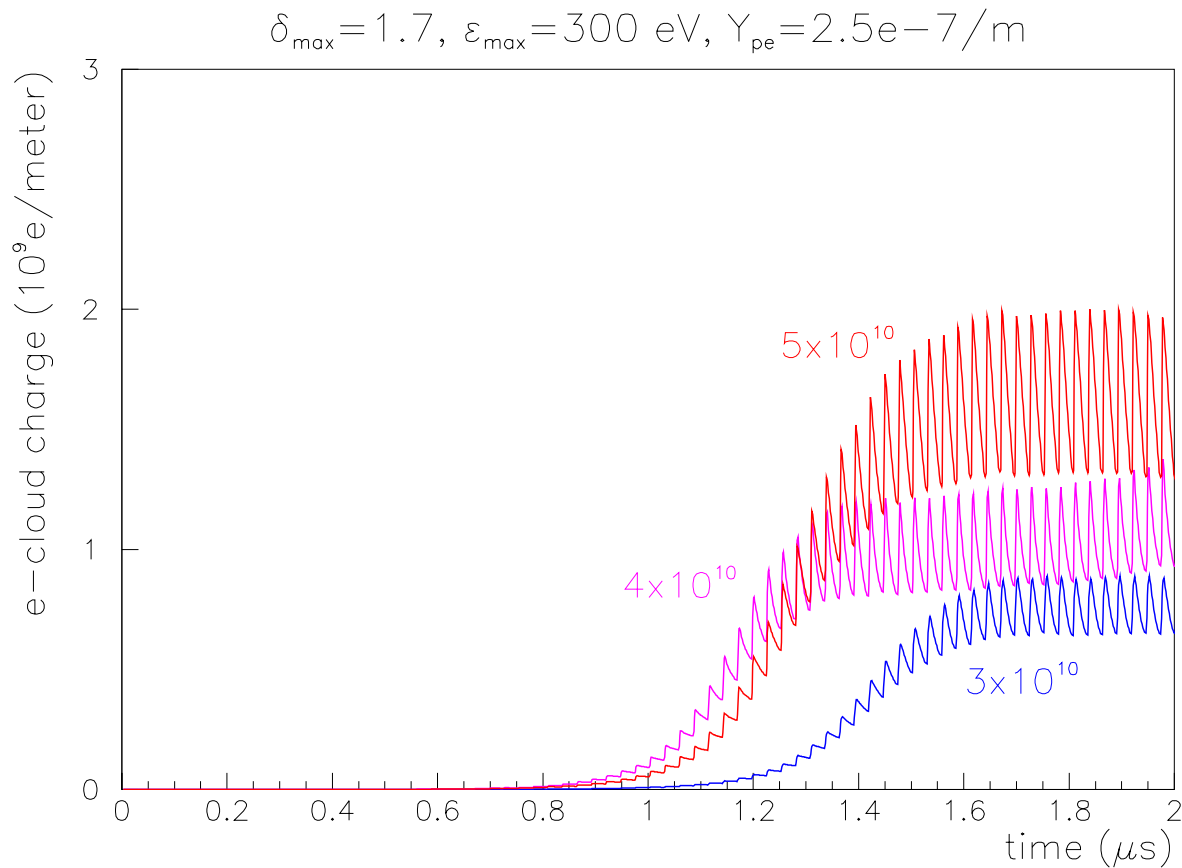
e^- cloud build up in the SPS



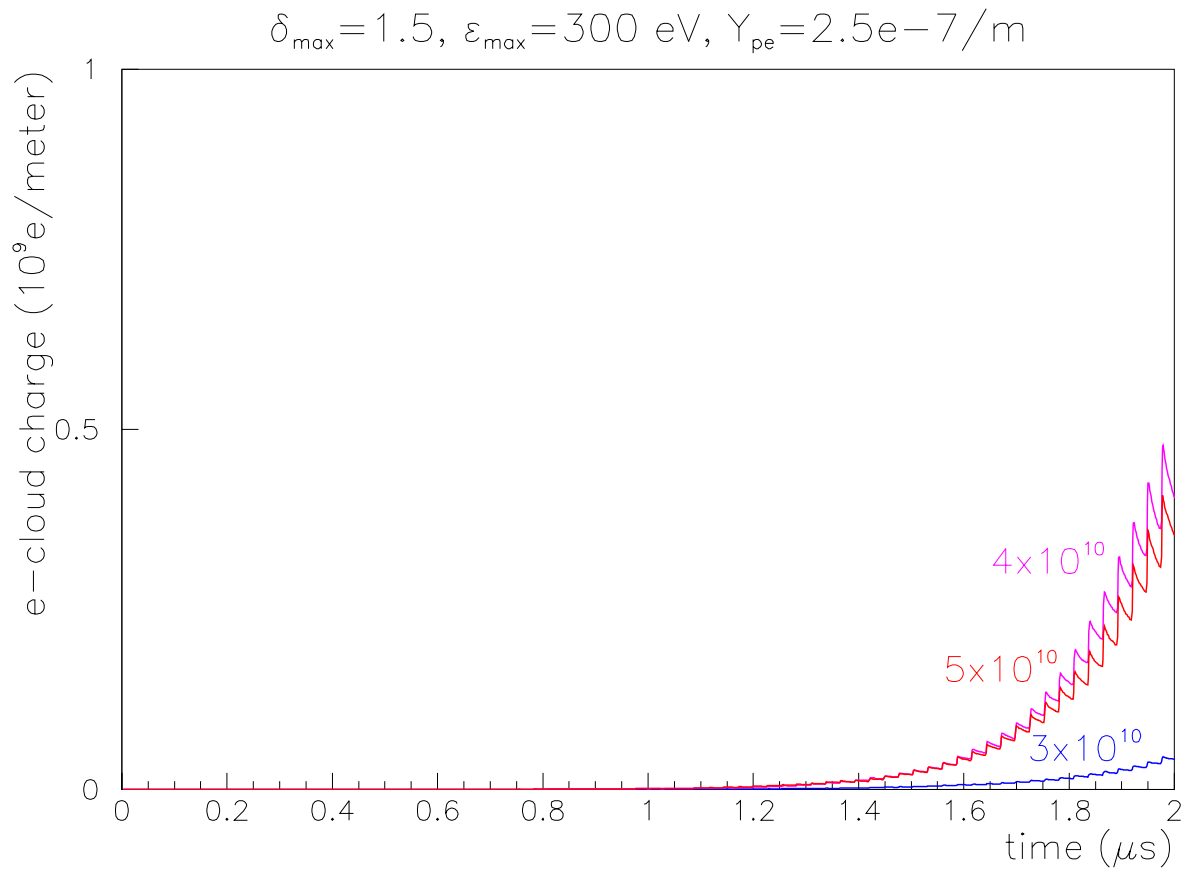
e^- cloud build-up in the SPS for $N_b = 5 \times 10^{10}$. The colors refer to different values of the maximum secondary emission yield δ_{\max} . Critical yield δ_{\max} between 1.1 and 1.3, similar to LHC.



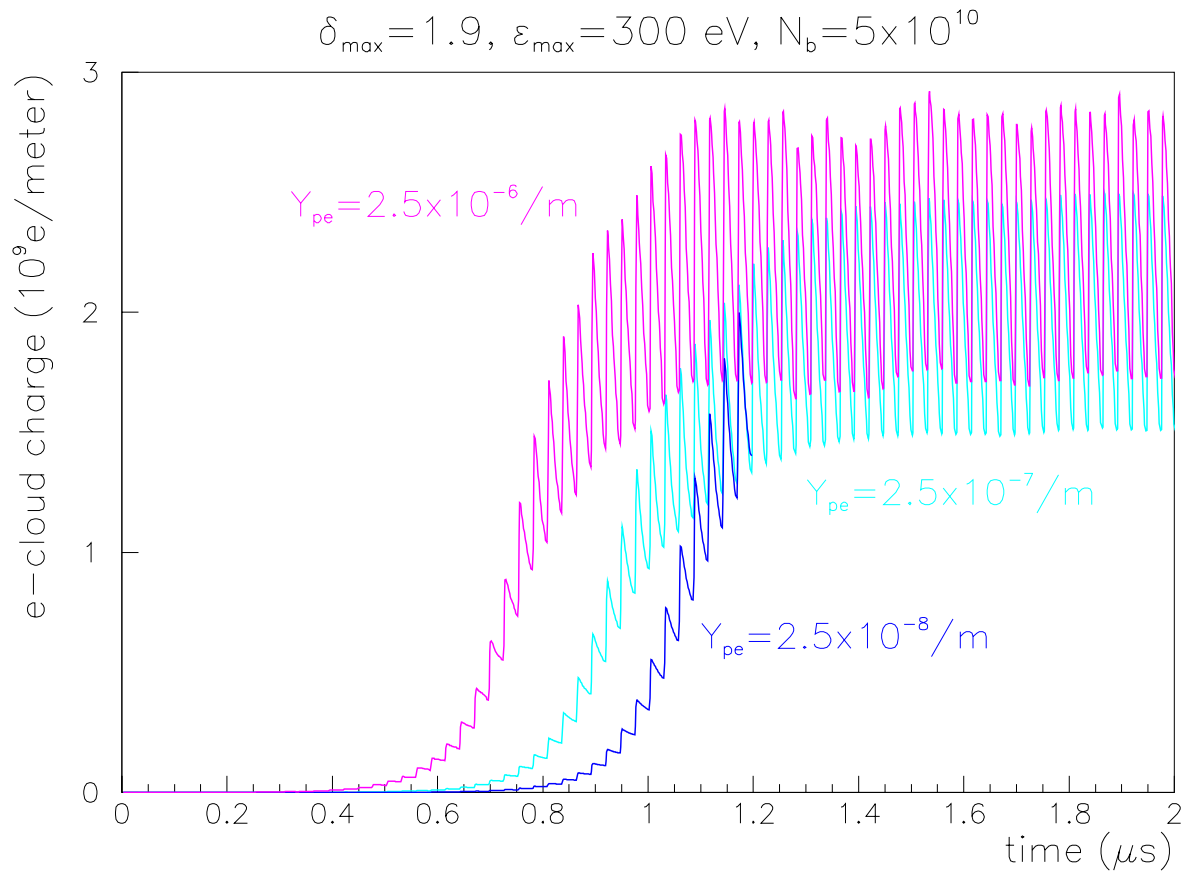
e^- cloud build-up in the SPS for 4 different bunch populations and $\delta_{\max} = 1.9$. The growth saturates for a few $10^9/m$ electron charge, consistent with pressure rise and damper pick-up data.



e^- cloud build-up in the SPS for 4 different bunch populations and $\delta_{\max} = 1.7$. The growth saturates for an electron charge of a few $10^9/m$, again consistent with pressure rise and damper pick-up data.



e^- cloud build-up in the SPS for 4 different bunch populations and $\delta_{\max} = 1.5$. The growth does not saturate.



Electron-cloud build up in the **SPS** for three different rates of primary electron creation, corresponding to **vacuum pressures of 5, 50 and 500 nTorr**. $N_b = 5 \times 10^{10}$, $\epsilon_{\max} = 300 \text{ eV}$, $R = 1$, $\delta_{\max} = 1.9$.

How large is the actual e^- cloud in the SPS?

(1) from pressure rise [O. Gröbner] :

pressure balance reads $S_{eff}P/(k_B T) = Q$, where S_{eff} pumping speed in volume per meter per second, $Q = \alpha \dot{\lambda}_e$ total flux of molecules per unit length (α : desorption yield per electron) and $P = k_B T N/V$.

$$\frac{d\lambda_e}{ds} = \frac{T_{rev}}{\alpha k_B T} S_{eff} P$$

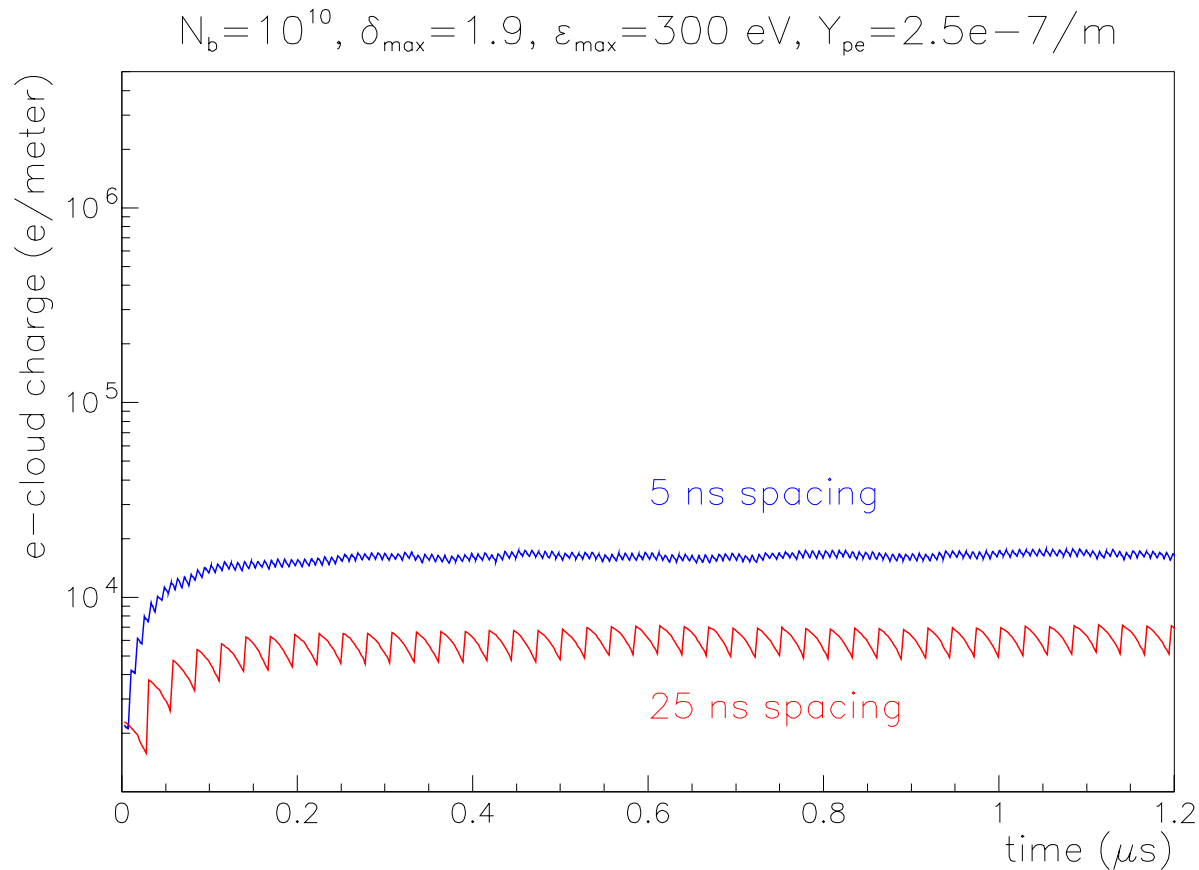
With $P = 100$ nTorr, $\alpha \approx 0.1$ and $S_{eff} \approx 20$ l s⁻¹ m⁻¹:

$$\frac{d\lambda_e}{ds} \approx 10^{10} \frac{\text{electrons}}{\text{bunch} - \text{train meter}}$$

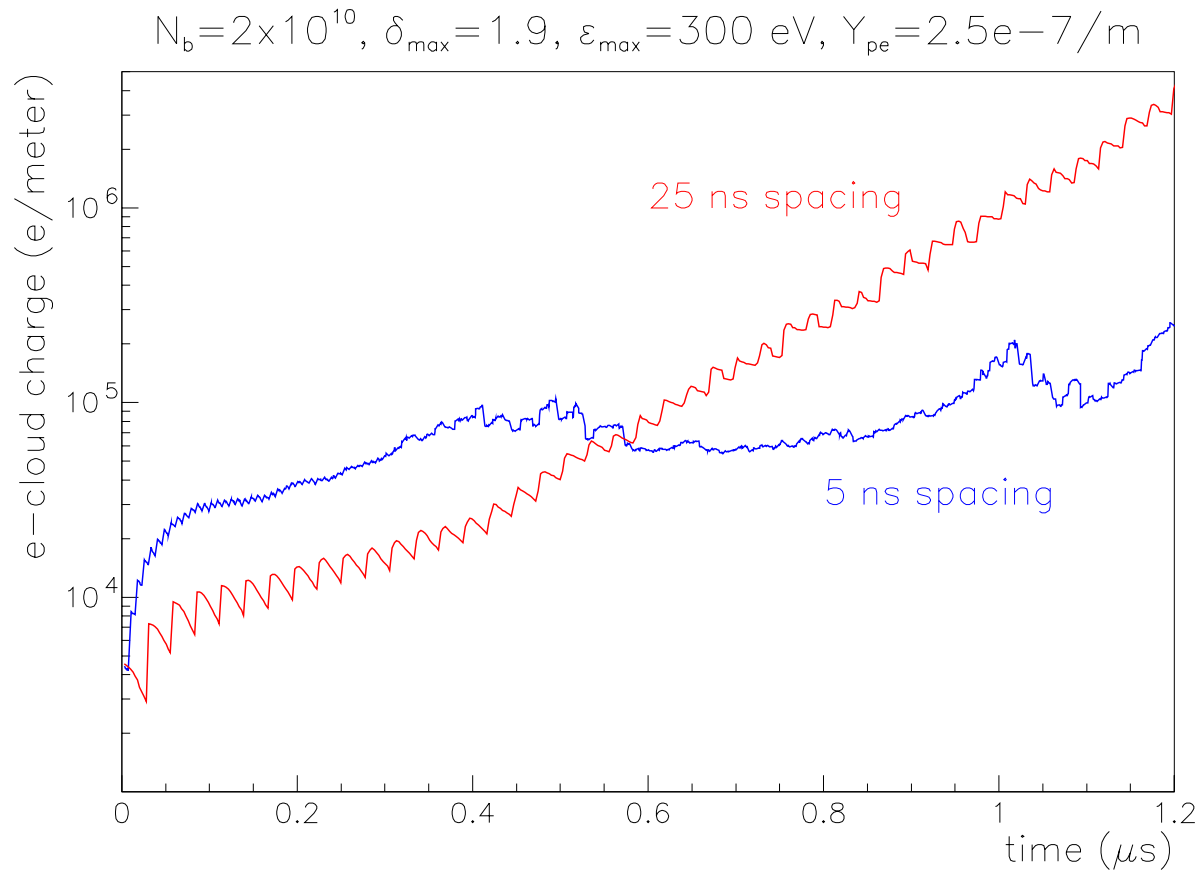
(2) from damper pick-up measurements [W. Hoefle]:
a few 10^8 electrons per bunch passage are deposited on the pick-up; this amounts to $10^9 - 10^{10}$ per train, or, with an effective pick-up length of about 10 cm,

$$\frac{d\lambda_e}{ds} \approx 10^{10} \frac{\text{electrons}}{\text{bunch} - \text{train meter}}$$

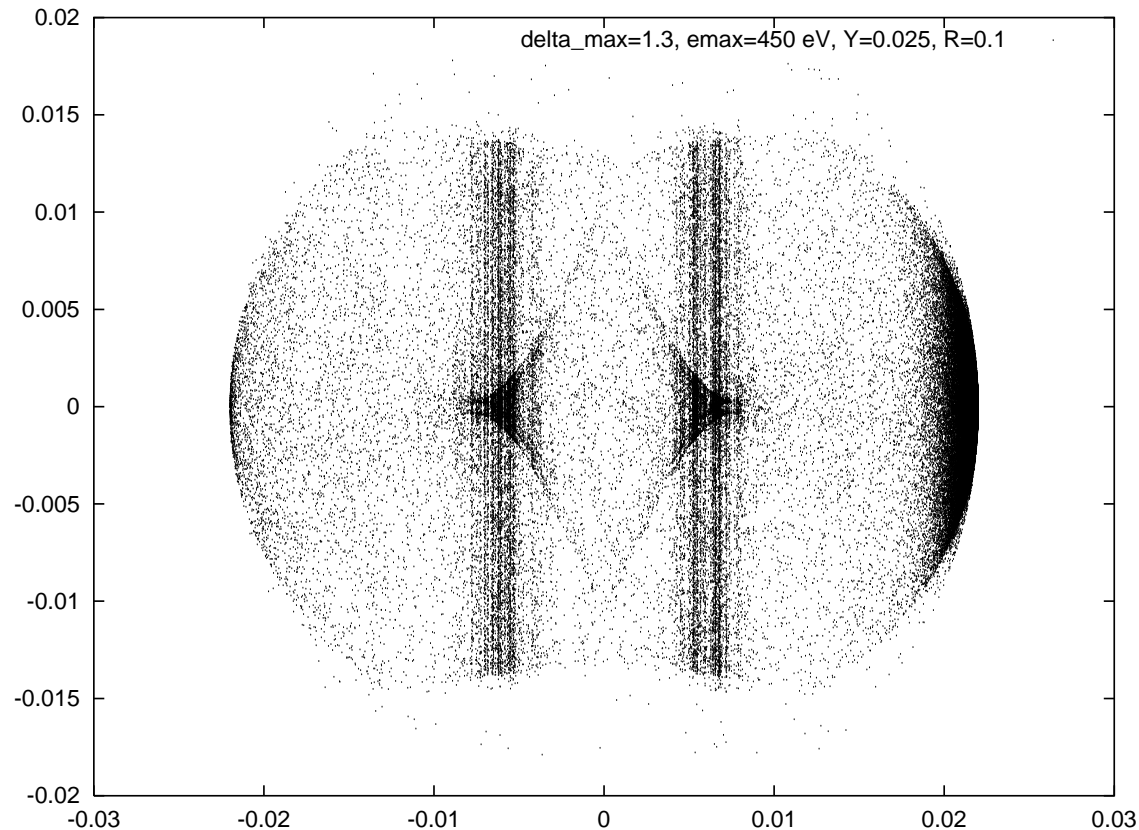
The two estimates are consistent.



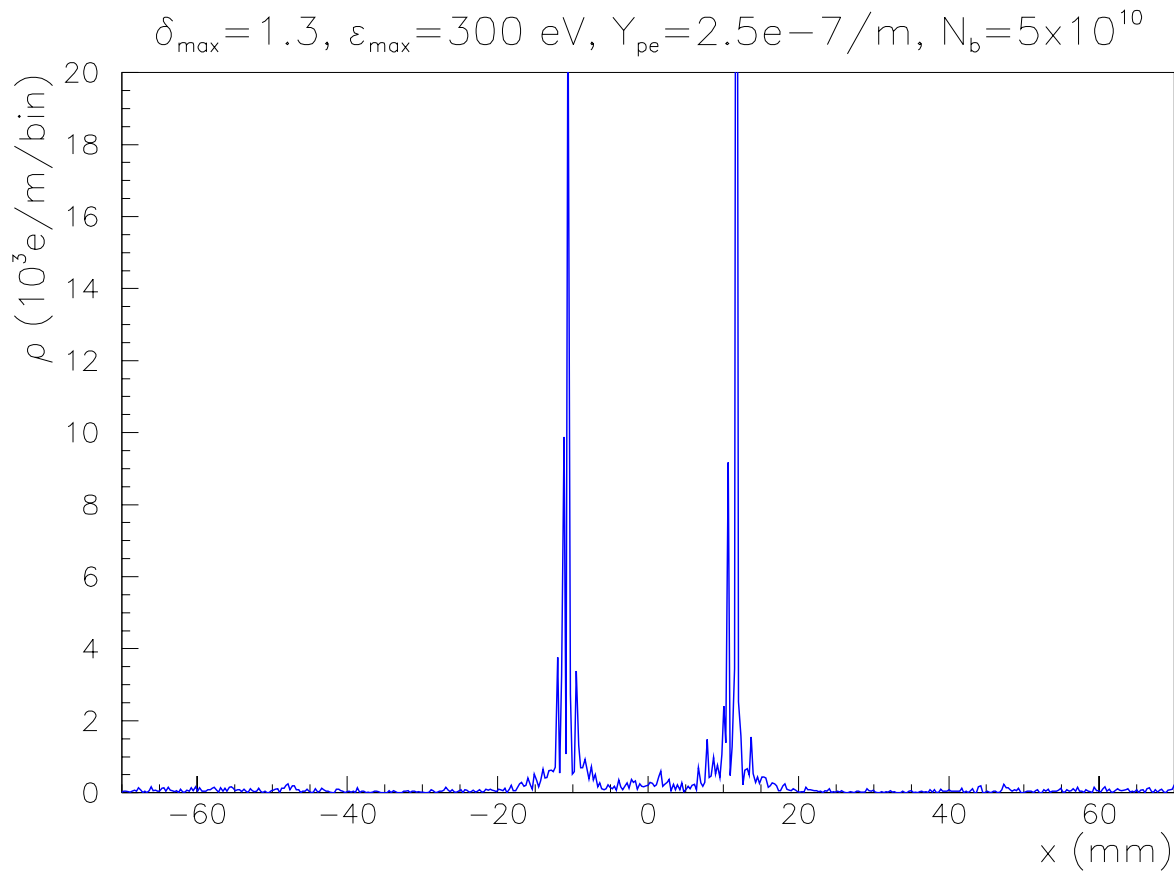
Electron-cloud build up in the **SPS** for a bunch population of $N_b = 10^{10}$, comparing bunch spacings of 5 ns and 25 ns. Other parameters: $\epsilon_{\max} = 300$ eV, $R = 1$, $\delta_{\max} = 1.9$, and $p = 50$ nTorr.



Electron-cloud build up in the **SPS** for a bunch population of $N_b = 2 \times 10^{10}$, comparing bunch spacings of 5 ns and 25 ns. Other parameters: $\epsilon_{\max} = 300$ eV, $R = 1$, $\delta_{\max} = 1.9$, and $p = 50$ nTorr.



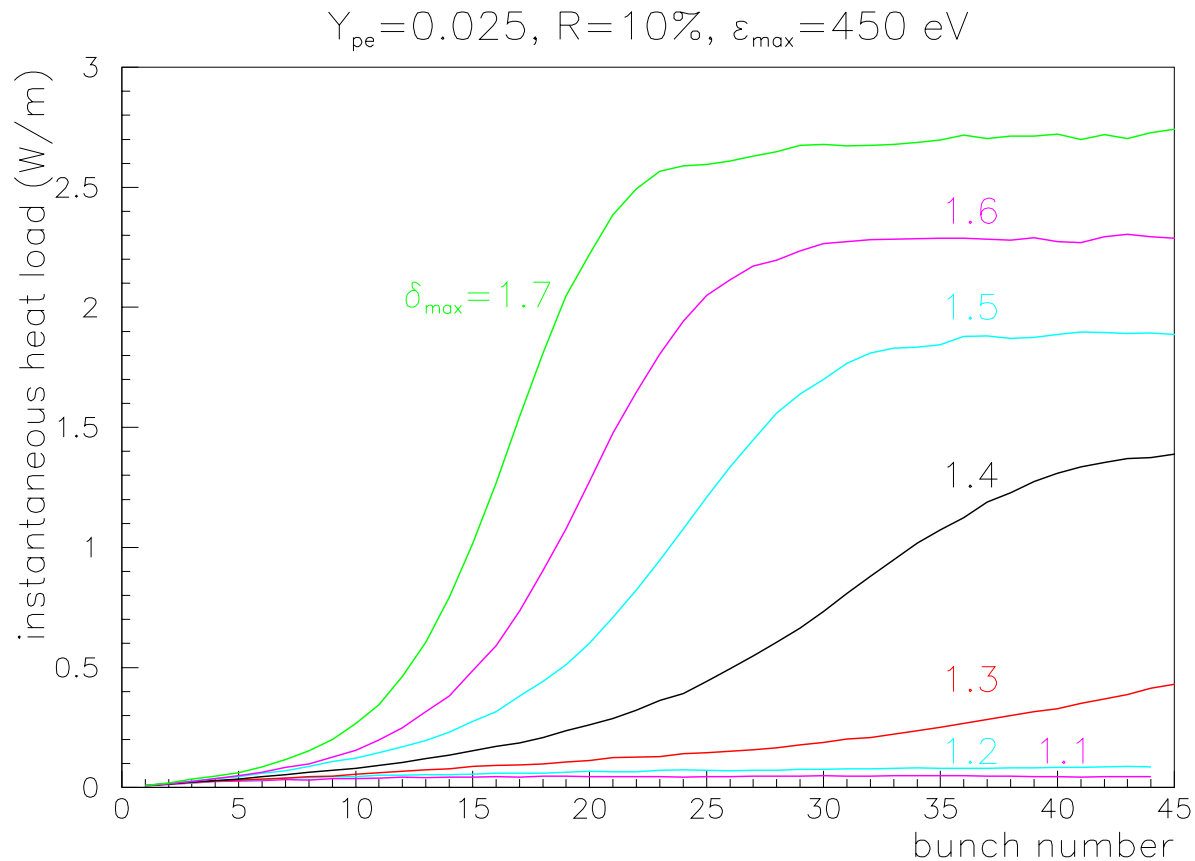
Snap shot of transverse **electron cloud distribution** in an LHC dipole chamber after 60 bunches with the design current. **Vertical stripes** indicate regions with large secondary emission. Parameters: $\delta_{\max} = 1.3$, $\epsilon_{\max} = 450$ eV, $R = 0.1$, and $Y^* = 0.025$.



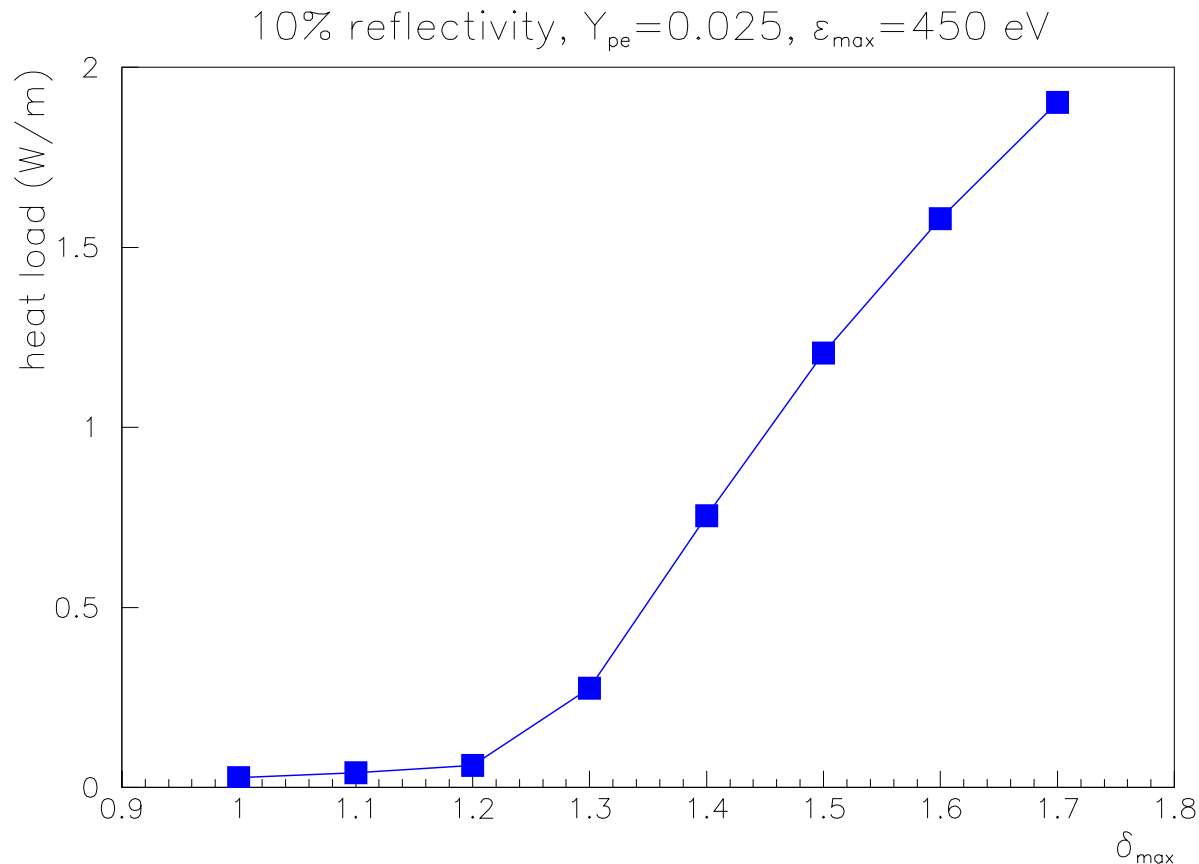
Projected horizontal electron charge density after 60 bunches in an SPS dipole chamber. Vertical peaks correspond to regions with large secondary emission. Parameters: $\delta_{\max} = 1.3$, $\epsilon_{\max} = 300 \text{ eV}$, $R = 1$, pressure 50 nTorr, and 500 bins.

Heat load from incident electrons is a concern for LHC:

- *LHC cryogenics system designed for maximum beam-screen heat load of 1 W/m*
- resistive heating by beam: 0.2 W/m
- synchrotron radiation: 0.2 W/m
- → *heat load from electron cloud must be smaller than 0.6 W/m*



Instantaneous heat load in W/m vs. bunch number for LHC dipole chamber. Parameters: $\epsilon_{\max} = 450 \text{ eV}$, $R = 0.1$, and $Y^* = 0.025$.



Heat load in LHC dipole chamber vs. maximum secondary emission yield δ_{max} . Parameters: $\epsilon_{max} = 450$ eV, $R = 0.1$, and $Y^* = 0.025$. The curve changes slope near the critical yield $\delta_{max} \approx 1.3$.

Parameters

variable	LHC initial	LHC final	SPS
δ_{max}	2.3	1.1	
ϵ_{max}	300 eV	450 eV	
$d\lambda_e/ds$	$1.4 \times 10^{-3} \text{ m}^{-1}$	$7 \times 10^{-4} \text{ m}^{-1}$	10^{-7} m^{-1}
Y	0.05	0.025	—
N_b	1.05×10^{11}	1.05×10^{11}	4×10^{10}

Simulated LHC heat loads

magnet	initial [†]	final [‡]
arc dipole	5000 mW/m	42 mW/m
D1 dipole*, 1 beam	2020 mW/m	15 mW/m
2 beams	7580 mW/m	90 mW/m
triplet quadrupole*, 1 beam	14 mW/m	6 mW/m
2 beams	32 mW/m	14 mW/m
drift with 3 cm aperture*, 1 beam	7500 mW/m	460 mW/m
2 beams	>16000 mW/m	630 mW/m

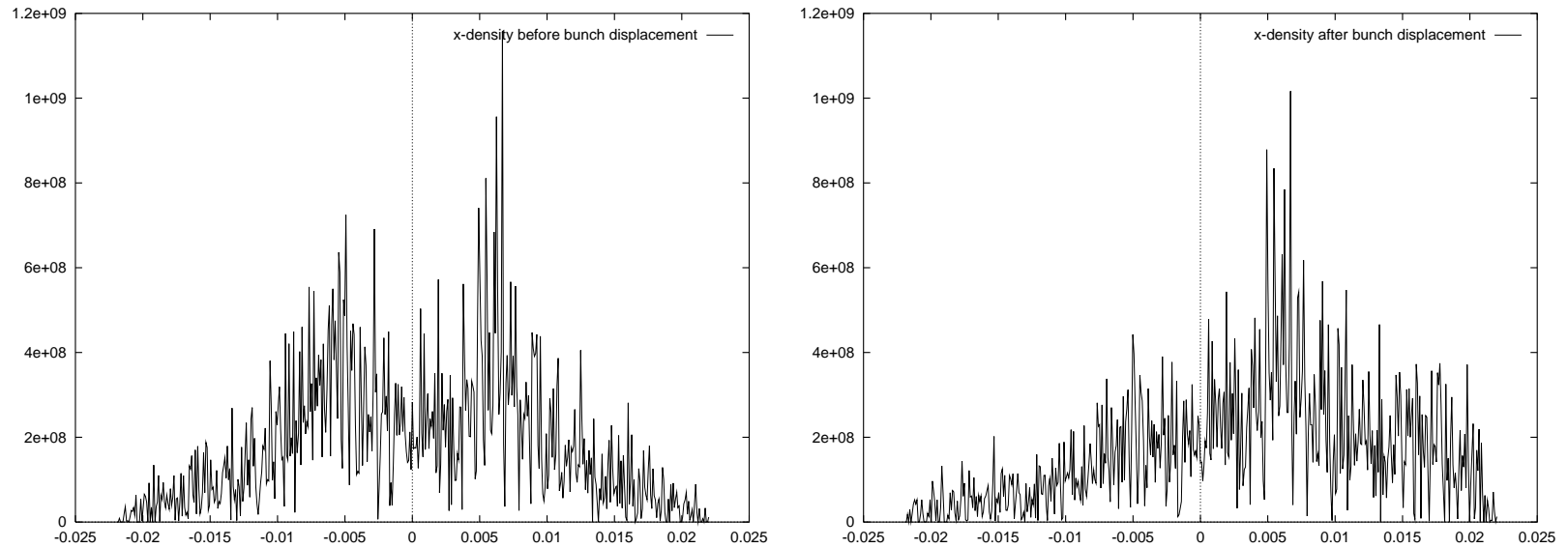
*with transverse offsets of 4–5 millimeters.

[†]with $\delta_{\max} = 2.3$, $\epsilon_{\max} = 300$ eV, $Y_{pe} = 0.05$.

[‡]with $\delta_{\max} = 1.1$, $\epsilon_{\max} = 450$ eV, $Y_{pe} = 0.025$.

Multibunch Wake

Electron cloud couples motion of subsequent bunches.



Projected horizontal electron charge density in an LHC bending magnet **before the 41st bunch in the train is horizontally displaced by 1 cm [left]** and **just prior to the arrival of the 42nd bunch [right]**. The horizontal axis is in units of meters; the vertical coordinate is the charge (in units of e) per bin and per grid point. Other parameters: 500 grid points, $\delta_{\max} = 1.7$, $R = 1$, $Y^* = 1$.

Effective wake and instability

electron cloud can couple motion of subsequent bunches
→ instability

- after stationary cloud is established, **displace 1 bunch transversely by Δx or Δy**
- calculate **kick** that the disturbed e^- exerts on the next bunch → short-range dipole wake field $W_1(L_{sep})$

$$W_1(L_{sep}) = \sum_i \frac{2y_i Q_i}{N_b r_i^2 (\Delta y)} \left(1 - \exp\left(-\frac{r_i^2}{2\sigma^2}\right) \right) \frac{C}{l_b}$$

where $r_i = (x_i^2 + y_i^2)^{1/2}$, l_b simulated length of bending magnet, and Q_i charge of i th macro-electron.

- assume **uniformly filled ring** with M bunches and a **short-range wake**
 → complex frequency shift of μ th mode is (see Alex Chao's book)

$$\Omega_{y(x)}^{(\mu)} - \omega_{\beta,y(x)} = \frac{N_b r_p c^2}{2\gamma C \omega_\beta} W_{1,y(x)} e^{i2\pi(\mu + Q_y(x))/M}$$

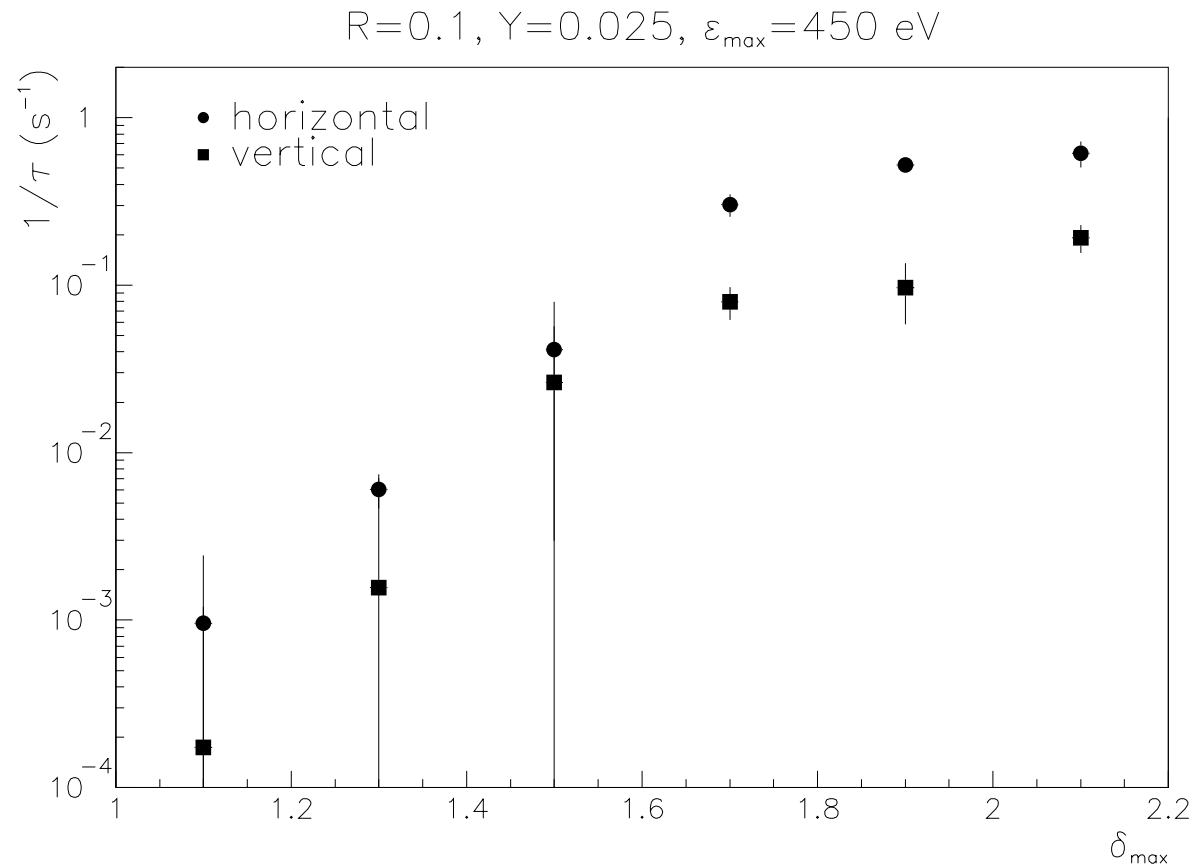
and shortest rise time

$$\tau \approx \frac{4\pi\gamma Q_y(x)}{N_b r_p c W_{1,y(x)}}$$

- with **clearing gaps** growth is not exponential but

$$y_n \sim \frac{1}{n!} (t/\tau)^n \hat{y}_0$$

for n th bunch in a train; τ is the same as above



Multibunch instability growth rate as a function of maximum secondary emission yield δ_{\max} for the LHC. Other parameters: $\epsilon_{\max} = 450 \text{ eV}$, $R = 10\%$, and $Y_{pe} = 0.025$.

Single-Bunch Instability

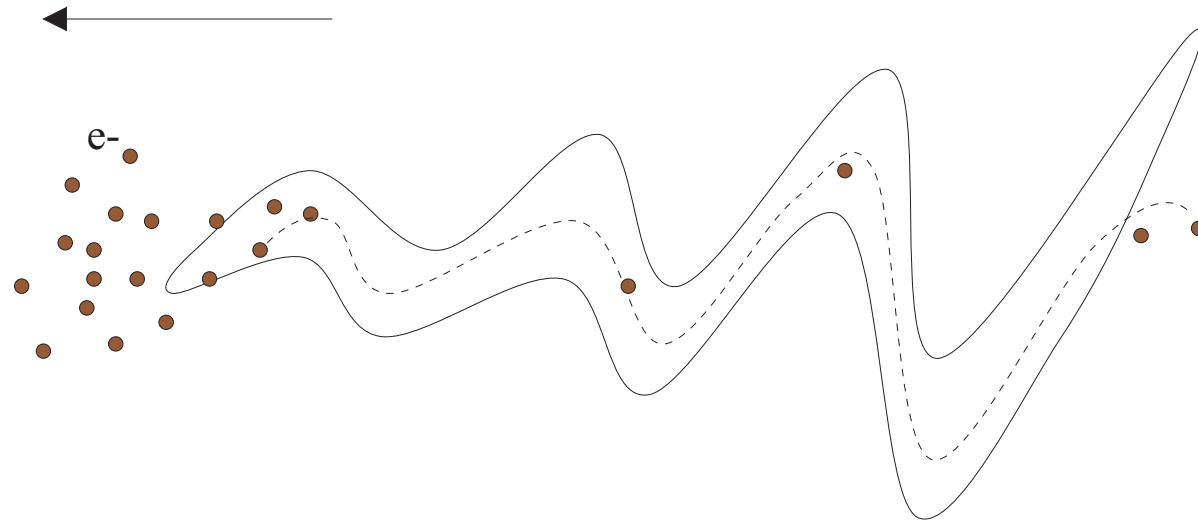


Illustration of a single-bunch instability driven by the electron-cloud.

Approximate growth rate:

$$\frac{1}{\tau} \approx 4\pi n_{\text{cloud}} \frac{N_b^{1/2} r_e^{1/2} r_p \sigma_z^{1/2} \sigma_x \beta_y c}{\gamma \sigma_y^{1/2} (\sigma_x + \sigma_y)^{3/2}}$$

Growth Rate Estimates

$$\frac{1}{\tau} [\text{s}^{-1}] \approx \begin{cases} 2 \times 10^{-8} n_{\text{cloud}} [\text{m}^{-3}] & \text{SPS at 26 GeV} \\ 6 \times 10^{-10} n_{\text{cloud}} [\text{m}^{-3}] & \text{LHC at 450 GeV} \\ 1 \times 10^{-10} n_{\text{cloud}} [\text{m}^{-3}] & \text{LHC at 7 TeV} \end{cases}$$

where n_{cloud} denotes the electron density near the beam.

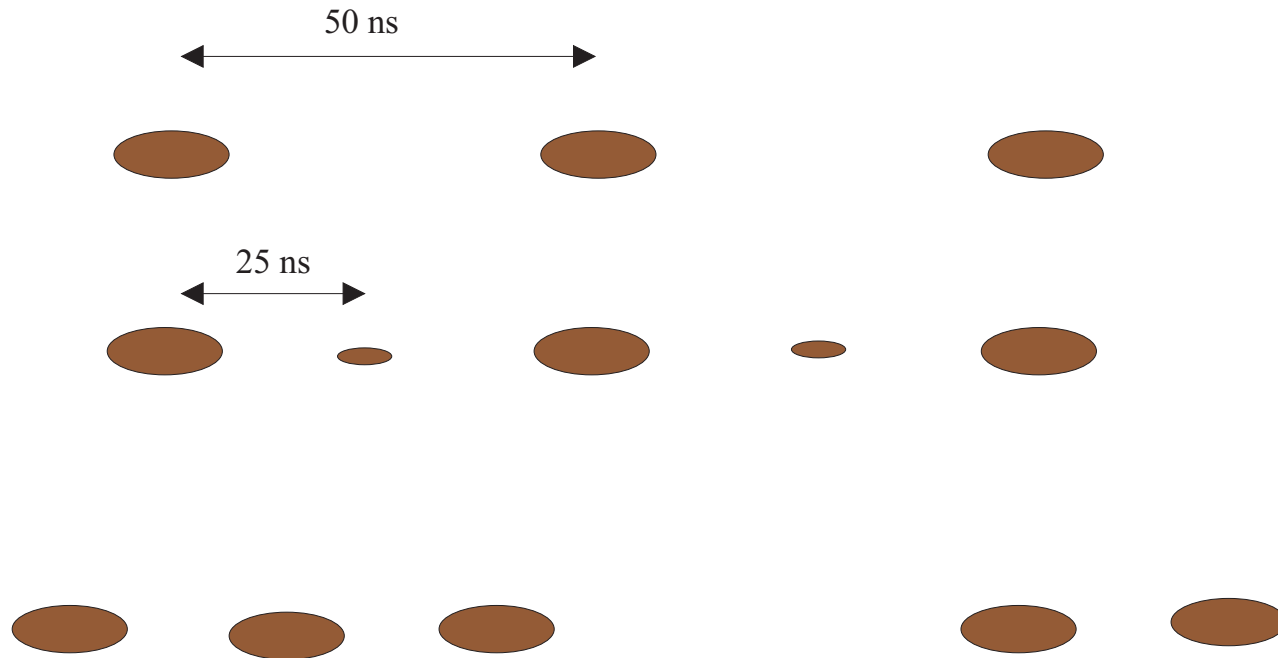
E.g., for the SPS with $n_{\text{cloud}} \approx 10^{11} \text{ m}^{-3}$: $\tau \approx 500 \mu\text{s}$.

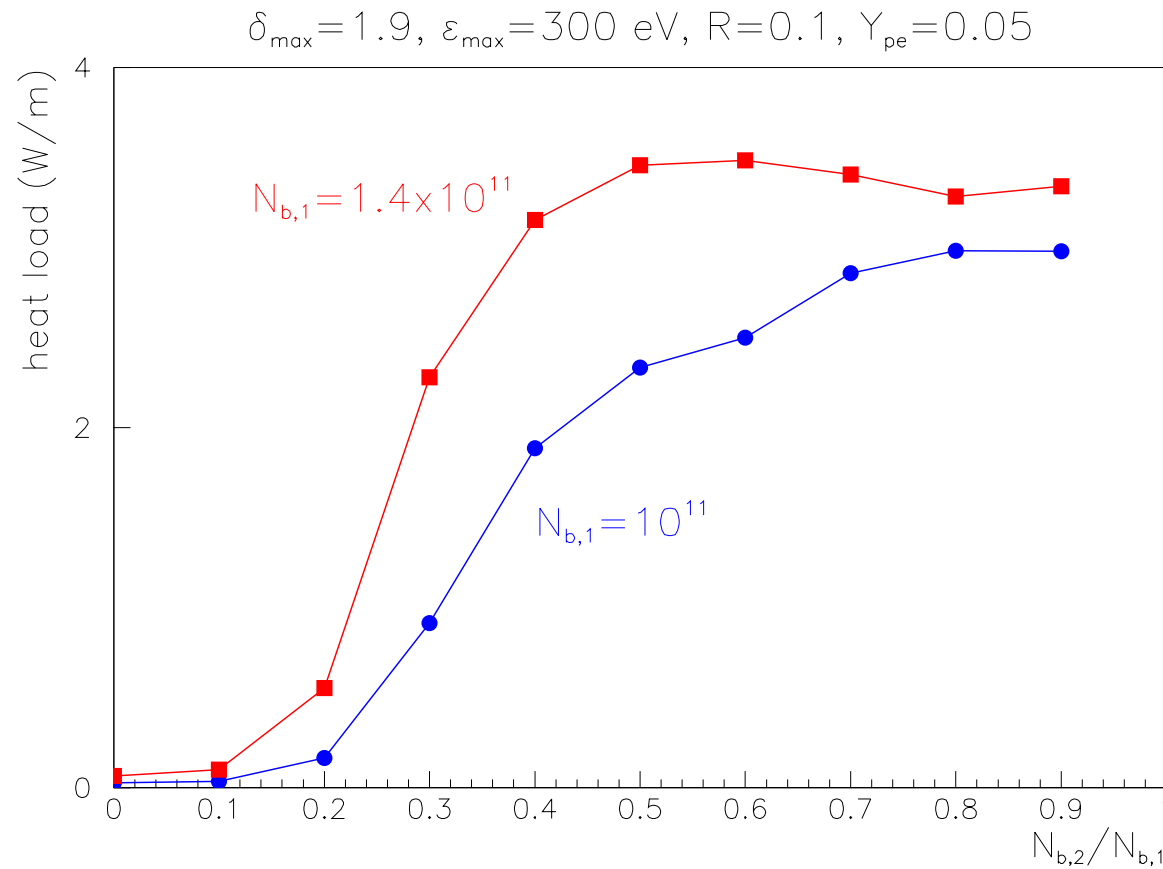
Similar instability due to ionization electrons created by the bunch itself: $\tau \approx 50 \text{ ms}$ at 10 nTorr ($\propto 1/\text{pressure}$).

Growth rate will be modified by synchrotron oscillations and chromaticity! (V_{rf}, Q', \dots)

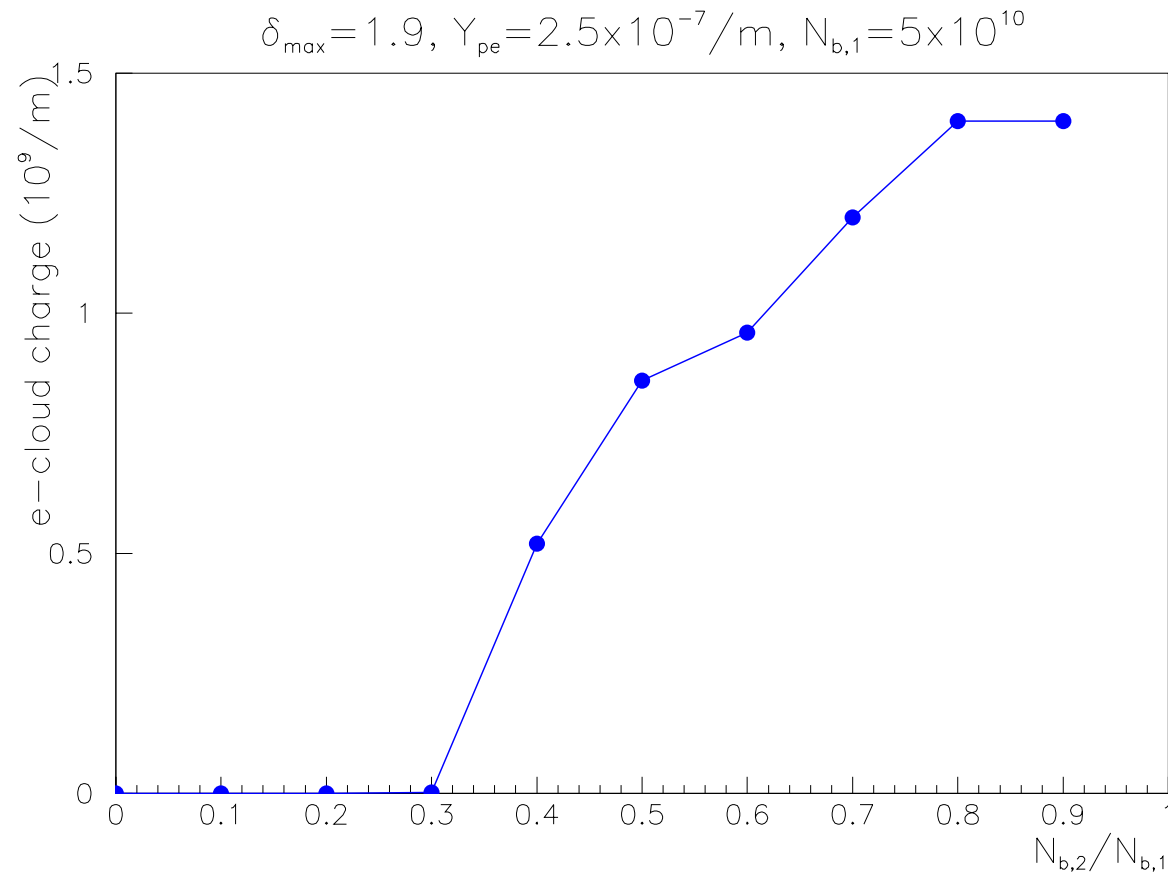
Possible Cures

Double bunch spacing or gaps in the train:



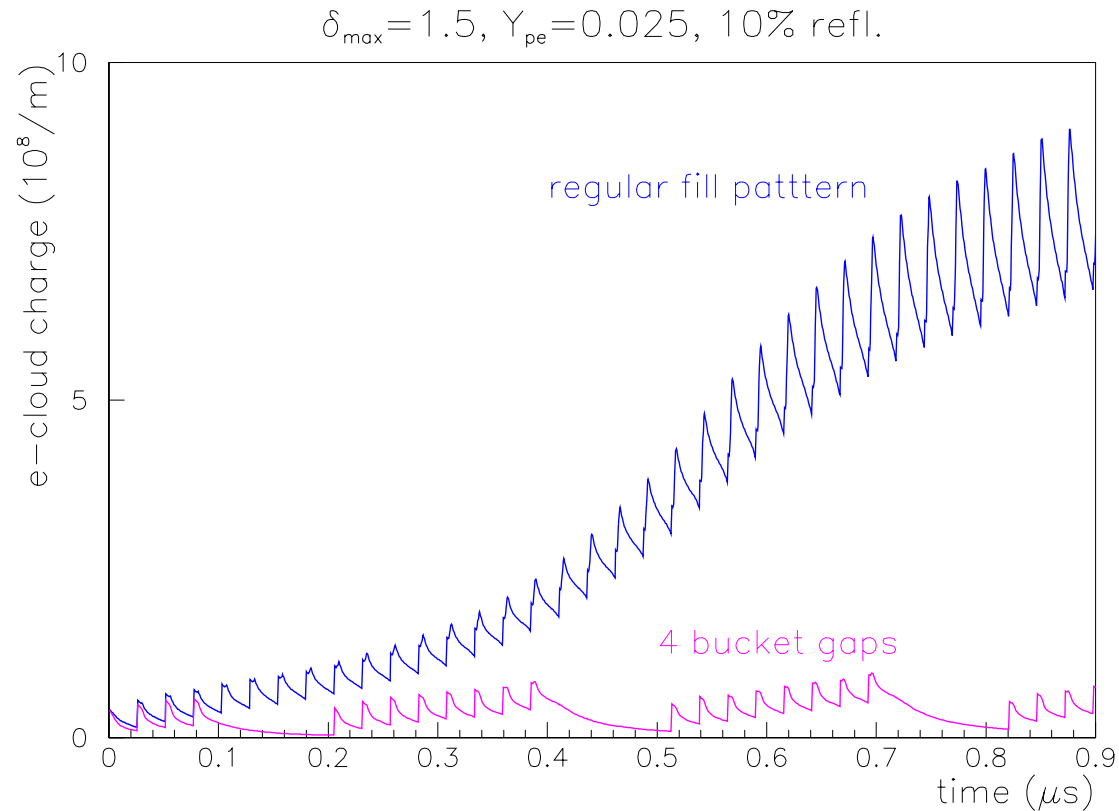


Heat load in an LHC dipole for twice the nominal bunch spacing and intermediate low-current bunches as a function of charge ratio $N_{b,2}/N_{b,1}$, for 2 values of $N_{b,1}$. $\epsilon_{\max} = 300 \text{ eV}$, photon reflectivity $R = 10\%$, $\delta_{\max} = 1.9$, and $Y_{pe} = 0.05$.



Electron-cloud charge in the SPS after bunch no. 60 for **twice the nominal bunch spacing** and intermediate low-current bunches as a function of charge ratio $N_{b,2}/N_{b,1}$ for $N_{b,1} = 5 \times 10^{10}$ and $\delta_{\max} = 1.9$.

Gaps in the LHC Bunch Train

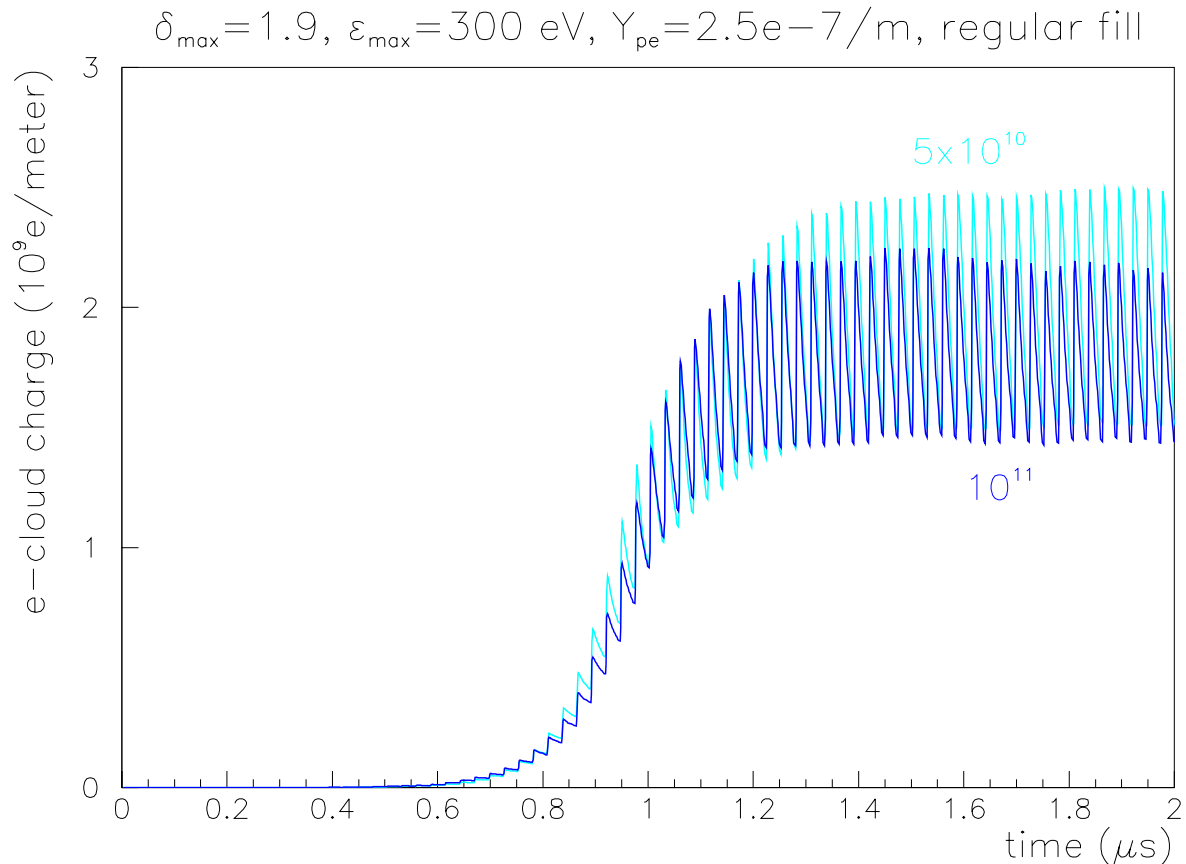


Suppression of charge build-up by gaps in the LHC bunch train; here a gap of 4 missing bunches after every 8 bunches.

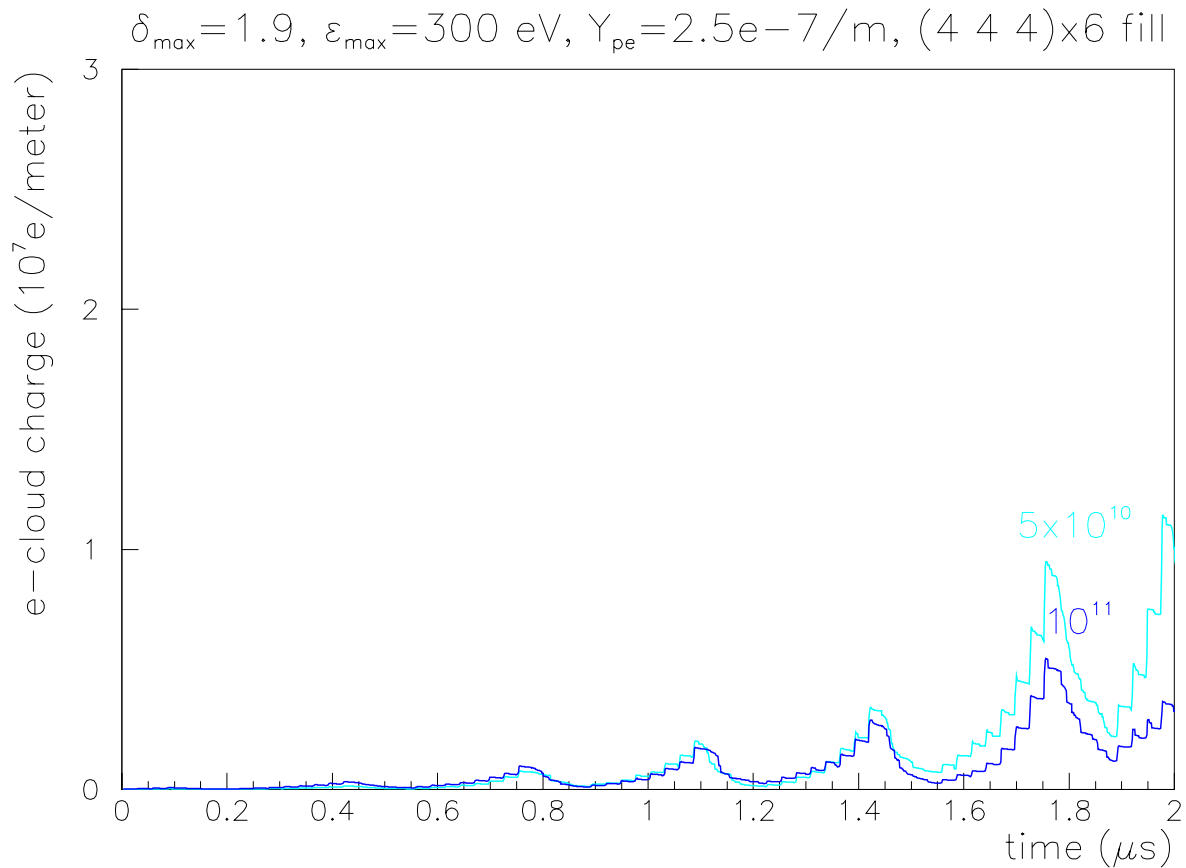
Heat load reduction in LHC dipole

δ_{\max}	regular fill	six gaps per train
1.1	41 mW/m	16 mW/m
1.3	222 mW/m	26 mW/m
1.5	564 mW/m	60 mW/m
2.3	5000 mW/m	890 mW/m

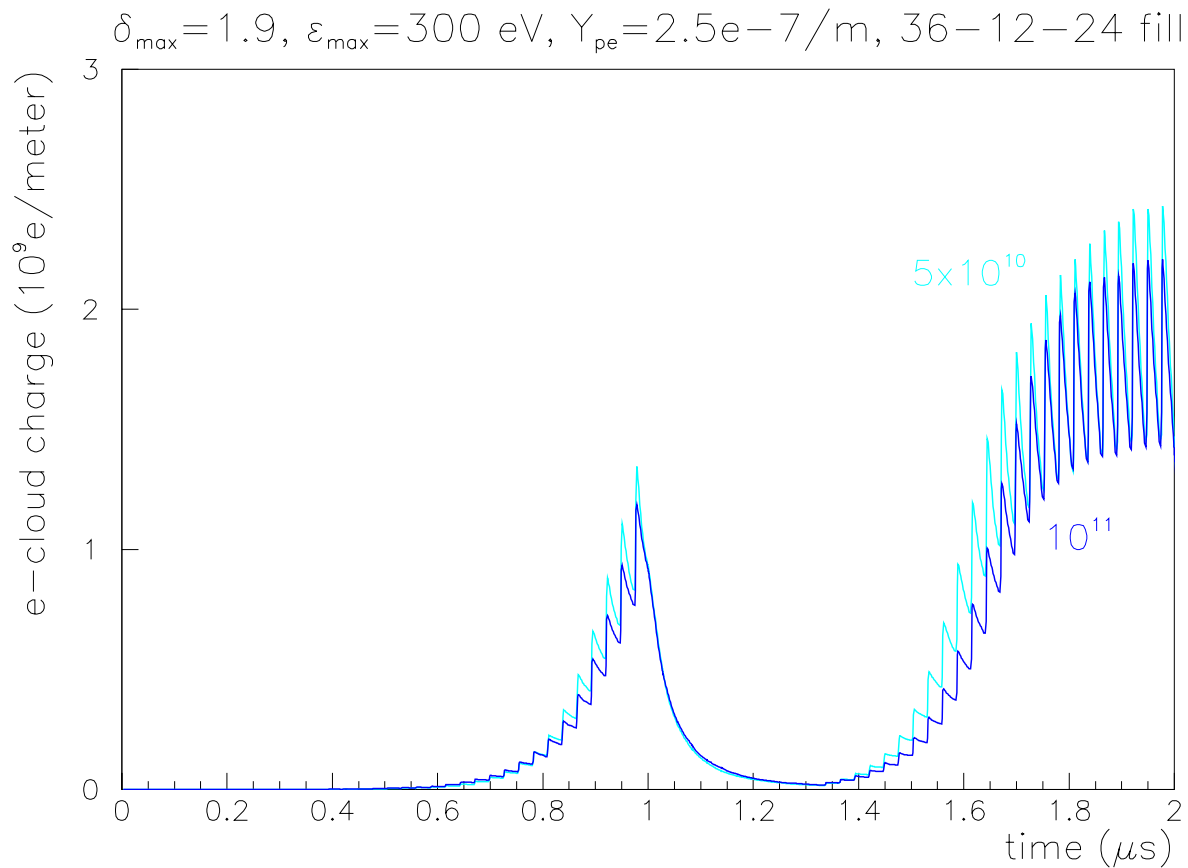
SPS Fill Patterns



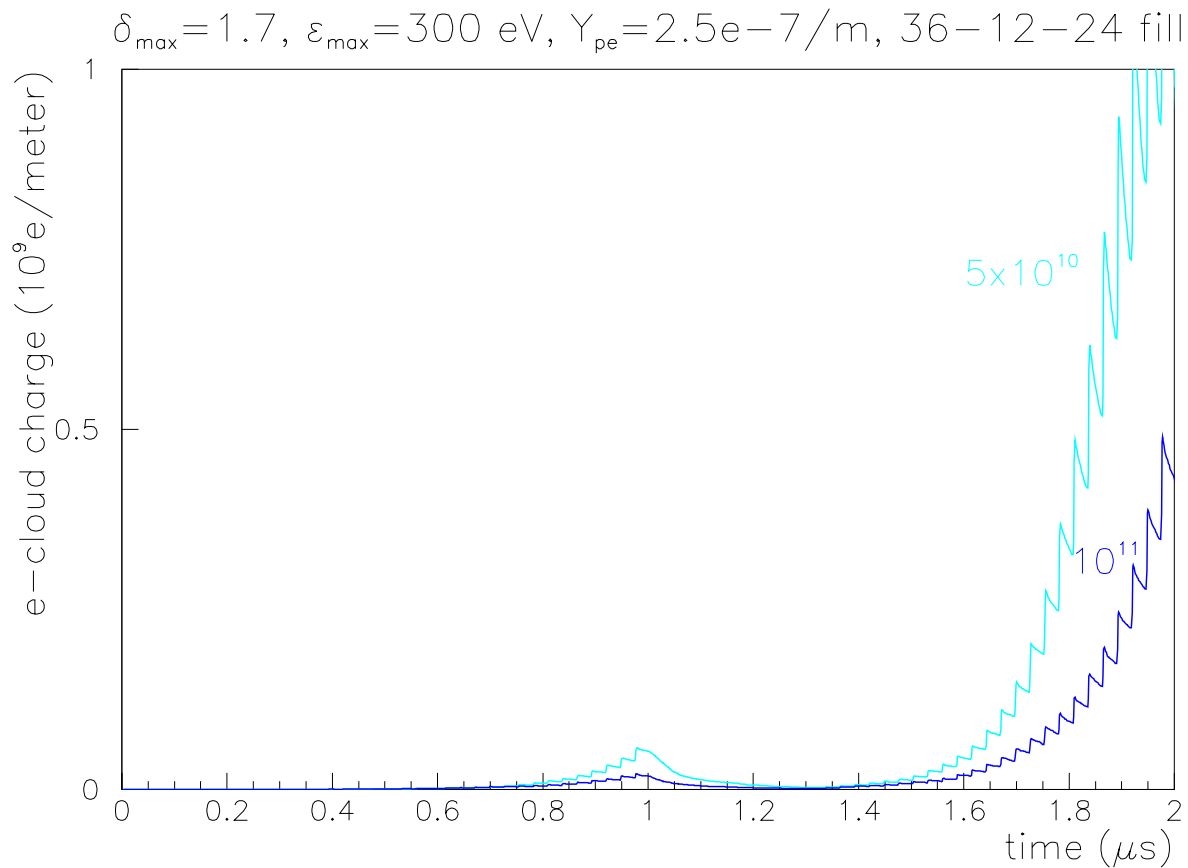
Electron cloud build up in the SPS for bunch populations of $N_b = 5 \times 10^{10}$ and 10^{11} (almost no difference!) and **regular fill**.



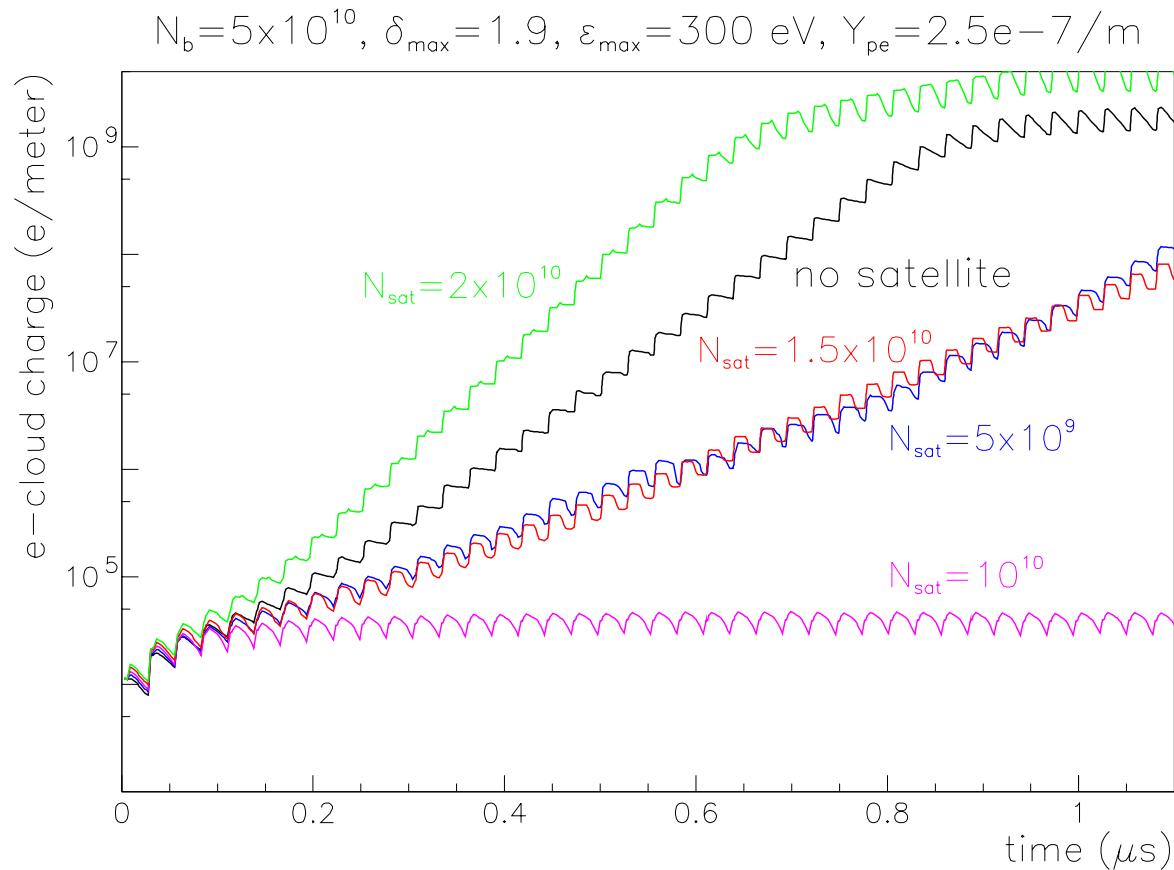
Electron cloud build up in the SPS for bunch populations of $N_b = 5 \times 10^{10}$ and 10^{11} and a fill pattern of $6 \times (4 \text{ bunches}, 4 \text{ empty buckets}, 4 \text{ bunches})$.



Electron cloud build up in the SPS for bunch populations of $N_b = 5 \times 10^{10}$ and 10^{11} (almost no difference!), $\delta_{\max} = 1.9$, and a fill pattern of 36 bunches, 12 empty buckets, 24 bunches.



Electron cloud build up in the SPS for bunch populations of $N_b = 5 \times 10^{10}$ and 10^{11} (almost no difference!), $\delta_{\max} = 1.7$, and a fill pattern of 36 bunches, 12 empty buckets, 24 bunches.



Electron-cloud build up in the **SPS** for **satellite bunches of various intensities**, following 3 ns behind the main bunches. Parameters:
 $N_b = 5 \times 10^{10}$, $\epsilon_{\max} = 300$ eV, $R = 1$, $\delta_{\max} = 1.9$, and $p = 50$ nTorr.

Summary I

- electron cloud effects depend on properties of vacuum chamber: δ_{\max} , ϵ_{\max} , (R, Y_{pe})
- critical yield for multipacting is $\delta_{crit} \approx 1.3$ for both LHC and SPS
- SPS observations are consistent with electron cloud and $\delta_{\max} \approx 1.9$

Summary II

- electron cloud causes pressure rise, **slow multibunch instability**, **single-bunch beam break up**, and **heat load** (at LHC)
- weak solenoids for LHC field free regions?
- emittance growth from single-bunch break up should depend on **rf voltage and chromaticity**
- **gaps in the bunch train** or **doubling the bunch spacing** or **satellite bunches** may help during surface conditioning